

SWCS048A - MARCH 2010 - REVISED AUGUST 2010

## **Power Management and USB Single Chip**

Check for Samples: TPS65921

## FEATURES

- 3 Step-Down Converters:
  - Up to 1.2 A of output current for DCDC1
  - SmartReflex<sup>™</sup> dynamic voltage management
  - 3.2 MHz fixed frequency operation
  - V<sub>IN</sub> range from 2.7 to 4.5 V
  - Typical 30 µA quiescent per converter
- 4 general-purpose configurable LDOs:
  - Dynamic voltage scaling
  - 220 mA maximum current for one LDO
  - V<sub>IN</sub> range from 2.7 to 4.5 V
  - 2 LDOs with low noise and high PSRR
- Backup battery charger
- RTC with alarm wake up mechanism
- 2.25 µA maximum in backup mode
- Clock management
  - 32-kHz crystal oscillator
  - Clock slicer for 26, 19.2, and 38.4 MHz
  - HF clock output buffer
- USB:
  - USB HS 2.0 transceiver
  - USB 1.3 OTG-compliant
  - 12-bit ULPI 1.1 interface
  - USB power supply (5-V CP for VBUS)
- Control
  - High-speed I<sup>2</sup>C<sup>™</sup> interface
  - All resource configurable by I<sup>2</sup>C
- Keypad interface up to 8 × 8
- 10-bit A/D converter
- Hot-die, thermal shutdown protection

PRODUCT PREVIEW information concerns products in the formative or design phase of development. Characteristic data and other specifications are design goals Tricas stumens serves the right to change or discontinue thes product without its re-

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## APPLICATIONS

- Mobile phones and smart phones
- MP3 players
- Handheld devices
- E-Books
- OMAP<sup>™</sup> and low power DSP supply

#### DESCRIPTION

The TPS65921 device is a highly integrated power-management circuit (IC) that supports the power and peripheral requirements of the OMAP application processors. The device contains power (USB) management, a universal serial bus high-speed (HS) transceiver, an analog-to-digital converter (ADC), a real-time clock (RTC), a keypad interface, and an embedded power control (EPC). The power portion of the device contains three buck converters, two controllable by a dedicated SmartReflex<sup>™</sup> class-3 interface, multiple low-dropout (LDO) regulators, an EPC to manage the power-sequencing requirements of OMAP, and an RTC and backup module. The RTC can be powered by a backup battery when the main supply is not present. Backup battery can be charged from the main battery. The USB module provides a HS 2.0 transceiver suitable for direct connection to the OMAP universal transceiver macrocell interface (UTMI) + low pin interface (ULPI) with an integrated charge pump (CP).

The device also provides auxiliary modules: ADC, keypad interface, and general-purpose inputs/outputs (GPIOs) muxed with the JTAG functions. The keypad interface implements a built-in scanning algorithm to decode hardware-based key presses and to reduce software use, with multiple additional GPIOs that can be used as interrupts when they are configured as inputs.

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#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
Main battery supply voltage <sup>(2)</sup>		0.0		5.0	V
Voltage on any input <sup>(3)</sup>	Where supply represents the voltage applied to the power supply pin associated with the input <sup>(4)</sup>	-0.3		1.0 × Supply + 0.3	V
VBUS input		-0.3		7	V
Storage temperature range		-55		125	°C
Operating ambient temperature (T <sub>A</sub> )		-40		85	°C
Operating junction temperature (T <sub>J</sub> )	Absolute maximum rating	-40		125	°C
Operating junction temperature (T <sub>J</sub> )	For parametric compliance	-40		150	°C
Ambient temperature for parametric compliance	With maximum 125°C as junction temperature (T <sub>J</sub> )	-40		85	°C

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(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device.

(2) The product will have negligible reliability impact if voltage spikes of 5.2 V occur for a total (cumulative over lifetime) duration of 10 milliseconds.

(3) Excepts VBAT input pads and VBUS pad.

(4) Supply equals the reference level of each pin.

#### **RECOMMENDED OPERATING CONDITIONS**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	MIN	TYP	MAX	UNIT
	Power and USB Path			1	
VBAT/VBAT.USB main ba	attery supply voltage and	2.7	3.6	4.5	V
BKBAT backup battery su	pply voltage	1.8	3.2	3.3	V
VBUS		0		7	V
	HFCLKIN Input Clock			1	1
Frequency 1/t <sub>C(HFCLKIN)</sub>		1	9.2, 26 or 38	.4	MHz
Pulse duration, HFCLKIN	low or high (BP)	0.45 × t <sub>C(HFCLKIN)</sub>		0.55 × t <sub>C(HFCLKIN)</sub>	ns
HFCLKIN stability		-150		150	ppm
Rise time of HFCLKIN (BP) 0				5	ns
Fall time of HFCLKIN (BP	)	0		5	ns
land data and a second	LP/HP (sine wave)	0.3	0.7	1.45	Vpp
Input dynamic range	BP/PD (square wave)	0		1.85 <sup>(1)</sup>	Vpp
Harmonic content of input LP/HP (sine wave)	signal (with 0.7-V <sub>PP</sub> amplitude): Second component -			-25	dBc
V <sub>IH</sub> voltage input high <sup>(1)</sup>	BP (square mode)	0.65 × IO.1P8			V
V <sub>IL</sub> voltage input low <sup>(1)</sup>	BP (square mode)			0.35 × IO.1P8	V
	Crystal Oscillator			·	
Parallel resonance crystal	frequency 1/t <sub>C(32KHZ)</sub>		32.768		kHz
Input voltage, Vin (normal	mode)	1.0	1.3	1.55	V
Crystal tolerance at room	temperature, 25°C	-30		30	ppm

(1) Bypass input maximum voltage is the same as the maximum voltage provided for the I/O interface (IO.1P8V).

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#### **RECOMMENDED OPERATING CONDITIONS (continued)**

over operating free-air temperature range (unless otherwise noted)

· *	emperature range (unless otherwise noted) mperature range (–40°C to 85°C)	-200		200	
Crystal quality factor		-200 13k		200 54k	ppm
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Maximum drive power				1	μW
Operating drive level	Orietal	400/		0.5	μW
32KXIN 32KXOUT duty cycle	Crystal	40%		60%	
	Square wave	45%		55%	
32-kHz clock rise/fall time	Square wave with capacitive load equivalent to 30 pF Square wave in bypass mode <sup>(1)</sup>			0.1 × t <sub>C(32KHZ)</sub>	μs
V <sub>IH</sub> voltage input high	0.65 × VBRTC			V	
V <sub>IL</sub> voltage input low	Square wave in bypass mode <sup>(1)</sup>			0.35 × VBRTC	V
	DCDC Converters and LDO	S		-	
VDD1.IN, VDD2.IN, VDD3. DCDC2, DCDC3 (VIO)	IN input voltage range for step-down converter DCDC1,	2.7	3.6	4.5	V
VMMC1.IN input voltage ra	ange for LDO VMMC	Maximum (2.7, output voltage selected + 250 mV)	3.6	4.5	V
VDAC.IN input voltage ran	ge for LDO VDAC	2.7	3.6	4.5	V
VAUX12S.IN input voltage	range for LDO VAUX	Maximum (2.7, output voltage selected + 250 mV)	3.6	4.5	V
VINT.IN input voltage rang	Maximum (2.7, output voltage selected + 200 mV)	3.6	4.5	V	
VPLLA3R.IN input voltage	range for LDO VPLL1	2.7	3.6	4.5	V
VDD1.OUT ouput voltage	range for DCDC1 step-down converter	0.6		1.45	V
VDD2.OUT ouput voltage	range for DCDC2 step-down converter	0.6		1.5	V
VDD3.OUT ouput voltage	range for DCDC3 (VIO) step-down converter		1.8/1.85		V
VMMC1.OUT output voltage	e range for LDO VMMC	1.85		3.15	V
VDAC.OUT output voltage	range for LDO VDAC	1.2		1.8	V
VAUX2.OUT output voltage	e range for LDO VAUX	1.3		2.8	V
VPLL1.OUT output voltage	e range for LDO VPLL	1.0		1.8	V
VINTANA1.OUT output vol	tage for LDO VINTANA1		1.5		V
VINTANA2.OUT output vol	tage for LDO VINTANA2		2.5/2.75		V
VINTUSB1P5V.OUT output	t voltage for LDO VINTUSB1P5	1.35	1.5	1.65	V
VINTUSB1P8V.OUT output	t voltage for LDO VINTUSB1P8	1.62	1.8	1.98	V
VUSB3P1V.OUT output vo	Itage for LDO VUSB3P1		3.1		V
VINTDIG.OUT output volta	ge range for LDO VINTDIG	1.35	1.5	1.65	V
VRTC.OUT output voltage	Normal mode	1.45	1.5	1.55	V
range	Backup mode	1.0	1.3	1.55	V
	External Components				
Crystal: Nominal load cap	on each oscillator input CXIN and CXOUT <sup>(2)</sup>	9	10	12.5	pF

(2) Nominal load capacitor on each oscillator input defined as CXIN = CXOUT = Cosc × 2 - (Cint + Cpin). Cosc is the load capacitor defined in the crystal oscillator specification, Cint is the internal capacitor, and Cpin is the parallel input capacitor.

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#### **RECOMMENDED OPERATING CONDITIONS (continued)**

over operating free-air temperature range (unless otherwise noted)

	mperature range (unless otherwise noted)	1			
Crystal ESR (3)				90	kΩ
Crystal shunt capacitance,		• -		1	pF
	Value	0.7	1	1.3	μH
External coil for DCDC1	DCR			0.1	Ω
	Saturation current	2.1			A
External coil for DCDC2	Value	0.7	1	1.3	μH
and DCDC3	DCR			0.1	Ω
	Saturation current	900			mA
External capacitor for DCDC1, DCDC2, DCDC3 connected to VDD1.IN, VDD2.IN, VDD3.IN, and VDD1.OUT, VDD2.OUT, VDD3.OUT	Value ESR at switching frequency	5	10	15 20	μF mΩ
Filtering capacitor for	Value	0.3	1	2.7	μF
VMCC1.IN, VDAC.IN, VAUX.IN, VPPLA3R.IN, VINT.IN, VBAT.USB, VMMC1.OUT, VDAC.OUT, VAUX2, VPPL1, VINTDIG, VINTANA1, VINTANA2, VRRTC	ESR	20		600	mΩ
Filtering capacitor for	Value	1.41	4.7	6.5	μF
VUSB3V1, VUSB1V8, VUSB1V5	ESR	20		600	mΩ
Filtering capacitor for voltage reference	Connected from $V_{REF}$ to REFGND	0.3	1	2.7	μF
	Filtering capacitor (Connected between VBUS.CPOUT and GND) and called CVBUS (See Figure in USB Chapter)	$\begin{array}{c} \text{1.41 (The}\\ \text{minimum}\\ \text{can be}\\ \text{reduced to}\\ \text{1.2 } \mu\text{F},\\ \text{provided the}\\ \text{charge-}\\ \text{pump is}\\ \text{only used to}\\ \text{supply}\\ \text{VUSB3V1}\\ \text{LDO)} \end{array}$	4.7	6.5	μF
External capacitor for charge pump and VBUS	Flying capacitor (Connected between CP.CAPP and CP.CAPM) called CVBUS.FC (See Figure in USB Chapter)	1.32 (The minimum can be reduced to 1.2 μF, provided the charge- pump is only used to supply VUSB3V1 LDO)	2.2	3.08	μF
	Filtering capacitor ESR for CVUSB.IN and CVBUS.FC			20	mΩ
	Filtering capacitor CVBUS.IN	5	10	15	μF

(3) The crystal motional resistance Rm relates to the equivalent series resistance (ESR) by the following formula:

$$ESR = R_m \left( 1 + \frac{C_0}{C_L} \right)$$

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Measured with the load capacitance specified by the crystal manufacturer. In fact, if CXIN = CXOUT = 10 pF, then CL = 5 pF. Parasitic capacitance from the package and board must also be considered.

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#### **RECOMMENDED OPERATING CONDITIONS (continued)**

over operating free-air temperature range (unless otherwise noted)

External capacitor for power reference filter	Filtering capacitor	0.3	1	2.7	μF
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#### **ELECTRICAL CHARACTERISTICS**

#### **CRYSTAL OSCILLATOR**

When selecting a crystal, the system designer must consider the temperature and aging characteristics of a crystal versus the user environment and expected lifetime of the system. The following table lists the switching characteristics of the oscillator.

	PARAMETER		MIN	ТҮР	MAX	UNIT	
Crystal: Internal capacitor on each input (Cint)			8	10	12	pF	
Crystal: Parallel in	put capacitance (Cpin)				1.0	pF	
Parallel resonance	e crystal frequency			32.768		kHz	
Pin-to-pin capacita	ance			1.6	1.8	pF	
Maximum drive power					1.0	μW	
Operating drive level					0.5	μW	
Crystal quality fact	tor		13k		54k		
4	Start-up time, all conditions	S			500		
t <sub>SX</sub>	Start-up time, 25°C				360	ms	
	Active current	High jitter mode			1.8		
I <sub>DDA</sub> consumption (configured through the LOJIT bit) Low jitter mode				0.8	μA		
		Low battery mode (1.2 V)			1		
IDDQ	Current consumption	Startup			8	μA	

#### **Table 1. Base Oscillator Switching Characteristics**

#### **CLOCK SLICER**

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PARAMETER	MODE <sup>(1)</sup>	MIN	ТҮР	MAX	UNIT	
Internal coupling capacitor		4.2	5	5.7	pF	
	LP	15		60	kΩ	
Parallel input resistance over 10 to 40 MHz range	HP	30		75	kΩ	
	BP/PD	1		100	MΩ	
	LP	0.3		0.8		
	HP	0.3		0.7		
Parallel input capacitance over 10 to 40 MHz range	BP/PD	0.08		1	pF	
	BP/PD	40		230		
Output duty cycle with $V_{IN} = 0.2 V_{PP}$	LP/HP	40%	50%	60%		
	LP	4		18		
Propagation delay	HP	3		15	ns	
	BP/PD	0.2		3		
Power supply rejection ratio sideband (1% RMS of supply voltage added sine 5 MHz)	LP/HP	26			dBc	
	LP			175	μA	
Current consumption at maximum input of 40 MHz	HP			235	μA	
	BP/PD			39	nA	
Power-up time	LP/HP			1	ms	

(1) Bypass input maximum voltage is the same as the maximum voltage provided for the I/O interface.

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PARAMETER	MODE <sup>(1)</sup>	MIN	ТҮР	MAX	UNIT
Output peak-to-peak jitter with an input peak-to-peak jitter < 0.1% and for jitter frequency below 300 kHz	LP/HP			0.2%	
Output peak-to-peak jitter with an input peak-to-peak jitter < 0.1% and for jitter frequency above 300 kHz	LP/HP			1.0%	

## 32KCLKOUT OUTPUT CLOCK

NAME	PARAMETER DESCRIPTION	MIN	ТҮР	MAX	UNIT
f	Frequency		32.768		kHz
CL	Load capacitance			40	pF
V <sub>OUT</sub>	Output clock voltage, depending on output reference level IO.1P8		1.8 <sup>(1)</sup>		V
V <sub>OH</sub>	Voltage output high	V <sub>OUT</sub> – 0.45		V <sub>OUT</sub>	V
V <sub>OL</sub>	Voltage output low	0		0.45	V

(1) The output voltage depends on output reference level which is IO.1P8.

The following table details the output clock timing characteristics. The following figure shows the 32KCLKOUT output clock waveform.

NAME	PARAMETER	DESCRIPTION	MIN	TYP	MAX	UNIT
CK0	1/t <sub>C(32KCLKOUT)</sub>	Frequency		32.768		kHz
CK1	t <sub>W(32KCLKOUT)</sub>	Pulse duration, 32KCLKOUT low or high	0.40 × t <sub>C(32KCLKOUT)</sub>		0.60 × <sup>t</sup> c(32KCLKOUT)	ns
CK2	t <sub>R(32KCLKOUT)</sub>	Rise time, 32KCLKOUT <sup>(1)</sup>			16	ns
CK3	t <sub>F(32KCLKOUT)</sub>	Fall time, 32KCLKOUT <sup>(1)</sup>			16	ns
	SSB Phase Noise	At 1-kHz offset from the carrier			-110	dBc/Hz

(1) The output capacitive load is equivalent to 30 pF.





## HFCLKOUT OUTPUT CLOCK

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The following table summarizes the HFCLKOUT output clock electrical characteristics.

#### Table 2. HFCLKOUT Output Clock Electrical Characteristics

NAME	PARAMETER DESCRIPTION	MIN	ТҮР	MAX	UNIT
f	Frequency	19.2, 26, or 38.4			MHz
CL	Load capacitance			30	pF
V <sub>OUT</sub>	Output clock voltage, depending on output reference level IO.1P8		1.8 <sup>(1)</sup>		V
V <sub>OH</sub>	Voltage output high	V <sub>OUT</sub> – 0.45		V <sub>OUT</sub>	V
V <sub>OL</sub>	Voltage output low	0		0.45	V

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(1) The output voltage depends on output reference level which is IO.1P8.



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The following table details the HFCLKOUT output clock timing characteristics.

NAME	PARAMETER	DESCRIPTION	MIN	ТҮР	MAX	UNIT
CHO1	1/t <sub>C(HFCLKOUT)</sub>	Frequency		19.2, 26, or 38.4	•	MHz
CHO2	t <sub>W(HFCLKOUT)</sub>	Pulse duration, HFCLKOUT low or high	0.4 × t <sub>C(HFCLKOUT)</sub>		0.6 × t <sub>C(HFCLKOUT)</sub>	ns
		Rise time, HFCLKOUT, low drive <sup>(1)</sup>				
		- Load: 5 pF			3.8	
01100		- Load: 10 pF			5.5	
CHO3	tr(HFCLKOUT)	Rise time, HFCLKOUT, high drive <sup>(1)</sup>				ns
		- Load: 10 pF			2.9	
		- Load: 20 pF			5.0	
		Fall time, HFCLKOUT, low drive <sup>(1)</sup>				
		- Load: 5 pF			3.5	
CU04		- Load: 10 pF			5.1	20
CHO4	<sup>t</sup> F(HFCLKOUT)	Fall time, HFCLKOUT, high drive <sup>(1)</sup>				ns
		- Load: 10 pF			2.7	
		- Load: 20 pF			4.7	

#### Table 3. HFCLKOUT Output Clock Switching Characteristics

(1) Low drive: MISC\_CFG[CLK\_HF\_DRV] = 0 (default) High drive: MISC\_CFG[CLK\_HF\_DRV] = 1

Figure 2 shows the HFCLKOUT output clock waveform.

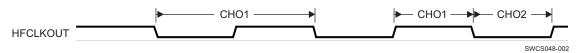
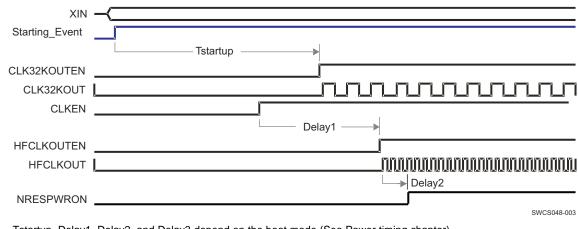




Figure 3 shows the 32KCLKOUT and HFCLKOUT clock stabilization time.



A. Tstartup, Delay1, Delay2, and Delay3 depend on the boot mode (See Power timing chapter).

Figure 3. 32KCLKOUT and HFCLKOUT Clock Stabilization Time

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HFCLKOUT

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#### Figure 4. HFCLKOUT Behavior

#### **DCDC1 CONVERTER**

PARAMETER	COMMENTS	MIN	TYP	MAX	UNIT	
Input voltage range		2.7	3.6	4.5	V	
Output voltage		0.6		1.45	V	
Output voltage step	0.6 to 1.45 V		12.5		mV	
Output accuracy <sup>(1)</sup>	0.6 to < 0.8 V	-6%		6%		
	0.8 to 1.45 V	-5%		5%		
Switching frequency			3.2		MHz	
	I <sub>O</sub> = 10 mA, sleep		82%			
<b>O</b>	100 mA < I <sub>O</sub> < 400 mA		85%			
Conversion efficiency <sup>(2)</sup>	400 mA < I <sub>O</sub> < 600 mA		80%			
	600 mA < I <sub>O</sub> < 800 mA	75%				
				1.2	A	
Output current				1.4	A	
	Sleep mode			10	mA	
	Off at 30°C			3		
Ground current (I <sub>Q</sub> )	Sleep, unloaded		30	50	μA	
	Active, unloaded, not switching			300		
Short-circuit current	V <sub>IN</sub> = V <sub>MAX</sub>		2.2		А	
Load regulation	$0 < I_O < I_{MAX}$			20	mV	
Transient load regulation <sup>(3)</sup>	$I_{O} = 10$ mA to 600 mA + 10 mA, maximum slew rate is 600 mA/100 ns	-65		50	mV	
Line regulation				10	mV	
Transient line regulation	300 mV_{PP} ac input, 10- $\mu s$ rise and fall time			10	mV	
Start-up time			0.25	1	ms	
Recovery time	From sleep to on with constant load		< 10	100	μs	
Slew rate (rising or falling) <sup>(4)</sup>		4	8	16	mV/µs	
Outrut ringle	Active (PWM and PSM)	-10		10	mV	
Output ripple	Sleep (PFM)	-2%	1	2%		

(1) Accuracy includes all variations (line and load regulations, line and load transients, temperature, and process).

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(2) VBAT = 3.6 V, VDD1 = 1.2 V, Fs = 3.2 MHz, L = 1  $\mu$ H, L<sub>DCR</sub> = 100 m $\Omega$ , C = 10  $\mu$ F, ESR = 10 m $\Omega$ 

(3) For negative transient load, the output voltage must discharge completely and settle to its final value within 100 ms. Transient load is specified at Vout max with a ±50% external capacitor accuracy and includes temperature and procress variation.

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(4) Load current varies proportional to the output voltage. The slew rate is for increasing and decreasing voltages and the load current is 1.1 A.

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PARAMETER	COMMENTS	MIN	ТҮР	MAX	UNIT
Current limit for PWM/PSM mode switch. PSM is below this limit, and PWM is above this limit.	Active mode	150		200	mA
Overshoot	Softstart			5%	
Output pulldown resistance	In Off mode		500	700	Ω

#### **DCDC2 CONVERTER**

PARAMETER	COMMENTS	MIN	TYP	MAX	UNIT
Input voltage range		2.7	3.6	4.5	V
Output voltage		0.6	1.0	1.5	V
Output voltage step	0.6 to 1.45 V		12.5		mV
Output accuracy <sup>(1)</sup>	0.6 to < 0.8 V	-6%		6%	
	0.8 to 1.45 V	-5%		5%	
Switching frequency <sup>(2)</sup>			3.2		MHz
	I <sub>O</sub> = 10 mA, sleep		82%		
Conversion efficiency <sup>(3)</sup>	100 mA < I <sub>O</sub> < 300 mA		85%		_
	300 mA < I <sub>O</sub> < 500 mA		80%		
0.1	Active mode			600	mA
Output current	Sleep mode			10	mA
	Off at 30°C			1	
Ground current (I <sub>Q</sub> )	Sleep, unloaded		30	50	μA
	Active, unloaded, not switching			300	_
Short-circuit current	V <sub>IN</sub> = V <sub>MAX</sub>		1.2		А
Load regulation	$0 < I_O < I_{MAX}$			20	mV
Transient load regulation <sup>(4)</sup>	$I_{O}$ = 10 mA to ( $I_{MAX}/3$ ) + 10 mA, maximum slew rate is $I_{MAX}/3/100$ ns	65		50	mV
Line regulation				10	mV
Transient line regulation	300 mV <sub>PP</sub> ac input, 10- $\mu$ s rise and fall time			10	mV
Output pulldown resistance	In OFF mode		500	700	Ω
Start-up time			0.25	1	ms
Recovery time	From sleep to on with constant load		25	100	μs
Slew rate (rising or falling) <sup>(5)</sup>		4	8	16	mV/µs
	Active (PWM and PSM)	-10		10	mV
Output ripple	Sleep (PFM)	-2%	1	2%	
Current limit for PWM/PSM mode switch. PSM is below this imit, and PWM is above this imit.	Active mode	150		200	mA
Overshoot	Softstart			5%	

(1) Accuracy includes all variations (line and load regulations, line and load transients, temperature, and process).

(2) Two modes are available:

Mode 1: VDD1 switcher uses its own RC oscillator clock (default).

Mode 2: VDD1 switcher could be configured to use delayed clock from VIO clock (based on HFCLKIN input clock).

(3) VBAT = 3.8 V, VDD1 = 1.3 V, Fs = 3.2 MHz, L = 1  $\mu$ H,  $L_{DCR}$  = 100 m $\Omega$ , C = 10  $\mu$ F, ESR = 10 m $\Omega$ 

(4) Output voltage must be able to discharge the load current completely and settle to its final value within 100 μs.

(5) Load current varies proportional to the output voltage. The slew rate is for increasing and decreasing voltages and the load current is 1.1 A.

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## **DCDC3 CONVERTER (VIO)**

PARAMETER	COMMENTS	MIN	ТҮР	MAX	UNIT	
Input voltage range		2.7	3.6	4.5	V	
Output voltage <sup>(1)</sup>			1.8 1.85		V	
	DC accuracy only	-3%		3%		
Output accuracy	Including all variations (line and load regulations, line and load transients, temperature, and process)	-4%		4%		
Switching frequency <sup>(2)</sup>			3.2		MHz	
	I <sub>O</sub> = 10 mA, sleep		85%			
Conversion efficiency <sup>(3)</sup>	100 mA < I <sub>O</sub> < 400 mA		85%			
	400 mA < I <sub>O</sub> < 600 mA		80%		]	
	On mode			700	mA	
Output current	Sleep mode			10	mA	
	Off at 30°C			1		
Ground current (I <sub>Q</sub> )	Sleep, unloaded		30	50	μA	
	Active, unloaded, not switching			300		
Load regulation	$0 < I_O < I_{MAX}$			20	mV	
Line regulation				10	mV	
Transient load regulation	$I_{O}$ = 10 mA to ( $I_{MAX}/3)$ + 10 mA, maximum slew rate is $I_{MAX}/3/100$ ns	-65		50	mV	
Transient line regulation	300 mV_{PP} ac input, 10- $\mu s$ rise and fall time			10	mV	
Start-up time			0.25	1	ms	
Recovery time	From sleep to on with constant load		< 10	100	μs	
Slew rate (rising or falling)		4	8	16	mV/µs	
	Active (PWM and PSM)	-10		10	mV	
Output ripple	Sleep (PFM)	-2%		2%		
Current limit for PWM/PSM mode switch. PSM is below this limit, and PWM is above this limit.	Active mode	150		200	mA	
Overshoot	Softstart			5%		
Output pulldown resistance	In Off mode		500	700	Ω	

(1)

TAT

This voltage is tuned according to the platform and transient requirements. Two modes are available: Mode 1: VIO switcher uses its own RC oscillator clock (default). ??? Mode 2:

(2) (3) VBAT = 3.8 V, VIO = 1.8 V, Fs = 3.2 MHz, L = 1  $\mu$ H, LDCR = 100 m $\Omega$ , C = 10  $\mu$ F, ESR = 10 m $\Omega$ 

## VMMC LOW DROPOUT REGULATOR

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IN</sub>	Input voltage		2.7	3.6	5.5	V
V <sub>OUT</sub>	Output voltage including all variations (line and load regulations, line and load transients, temperature, and process)		1.7945 2.7645 2.91 3.0555	1.85 2.85 3.0 3.15	1.9055 2.9355 3.09 3.2445	V
I <sub>OUT</sub>	Rated output current	On mode Low-power mode			220 5	mA
	DC load regulation	On mode: $0 < I_O < I_{MAX}$			20	mV

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STRUMENTS

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	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	DC line regulation	On mode, $V_{IN} = V_{INmin}$ to $V_{INmax}$ at $I_{OUT} = I_{OUTmax}$			3	mV
	Turn-on time	$I_{OUT}$ = 0, $C_L$ = 1 $\mu F$ (within 10% of $V_{OUT})$			100	μs
	Wake-up time	Full load capability			10	μs
		f < 10 kHz	50			
	Dipple rejection	10 kHz < f < 100 kHz	40			dD
	Ripple rejection	f = 1 MHz	25			dB
		$V_{IN} = V_{OUT} + 1 V$ , $I_O = I_{MAX}$				
		On mode, I <sub>OUT</sub> = 0			70	
		On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			290	
	Ground current	Low-power mode, $I_{OUT} = 0$			17	μA
		Low-power mode, $I_{OUT} = 5$ mA			20	μ
		Off mode at 55°C			1	
/ <sub>DO</sub>	Dropout voltage <sup>(1)</sup>	On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			250	mV
	Transient load regulation <sup>(2)</sup>	I <sub>LOAD</sub> : I <sub>MIN</sub> – I <sub>MAX</sub> Slew: 40 mA/μs	-40		40	mV
	Transford the second states	V <sub>IN</sub> drops 500 mV			40	
	Transient line regulation	Slew: 40 mV/µs			10	mV
	Overshoot	Softstart			3%	
	Pulldownresistance	Default in off mode	250	320	450	Ω

(1) For nominal output voltage

(2) Transient load regulation is always included in the overall accuracy of the selected output voltage option. For voltage levels that have a tighter output voltage specification than the transient load regulation, follow the output voltage specification.

#### VDAC LOW DROPOUT REGULATOR

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
V <sub>IN</sub>	Input voltage		2.7	3.6	4.5	V
V <sub>OUT</sub>	Output voltage including all variations (line and load regulations, line and load transients, temperature, and process)		1.164 1.261 1.746	12 1.3 1.8	1.236 1.339 1.854	v
I <sub>OUT</sub>	Rated output current	On mode			70	mA
001		Low-power mode			5	
	DC load regulation	On mode: $0 < I_O < I_{MAX}$			20	mV
	DC line regulation	On mode, $V_{IN} = V_{INmin}$ to $V_{INmax}$ at $I_{OUT} = I_{OUTmax}$			3	mV
	Turn-on time	$I_{OUT}$ = 0, $C_L$ = 1 $\mu F$ (within 10% of $V_{OUT})$			100	μs
	Wake-up time	Full load capability			10	μs
		f < 20 kHz	65			
	Disale rejection	20 kHz < f < 100 kHz	45			dB
	Ripple rejection	f = 1 MHz	40			uБ
		$V_{IN} = V_{OUT} + 1 V$ , $I_O = I_{MAX}$				
		200 Hz < f < 5 kHz			400	
	Output noise	5 kHz < f < 400 kHz			125	nV/√Hz
		400 kHz < f < 10 MHz			50	

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	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		On mode, I <sub>OUT</sub> = 0			150	
		On mode, $I_{OUT} = I_{OUTmax}$			350	
	Ground current	Low-power mode, $I_{OUT} = 0$			15	μA
		Low-power mode, $I_{OUT} = 1$ mA			25	μΛ
		Off mode at 55°C			1	
V <sub>DO</sub>	Dropout voltage <sup>(1)</sup>	On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			250	mV
	Transient load regulation <sup>(2)</sup>	I <sub>LOAD</sub> : Ι <sub>MIN</sub> – Ι <sub>MAX</sub> Slew: 60 mA/μs	-40		40	mV
	Transient line regulation	V <sub>IN</sub> drops 500 mV Slew: 40 mV/μs			10	mV
	Overshoot	Softstart			3%	
	Pull down resistance	Default in off mode	250	320	450	Ω

(1) For nominal output voltage

(2) Transient load regulation is always included in the overall accuracy of the selected output voltage option. For voltage levels that have a tighter output voltage specification than the transient load regulation, follow the output voltage specification.

#### VAUX LOW DROPOUT REGULATOR

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
V <sub>IN</sub>	Input voltage		2.7	3.6	4.5	V
V <sub>OUT</sub>	Output voltage including all variations (line and load regulations, line and load transients, temperature, and process)		-3%	1.3 1.5 1.7 1.8 1.9 2.0 2.1 2.2 2.3 2.4 2.5 2.8	+3%	v
1	Rated output current	On mode			100	mA
I <sub>OUT</sub>	Rated output current	Low-power mode			5	ША
	DC load regulation	On mode: $0 < I_O < I_{MAX}$			20	mV
	DC line regulation	On mode, $V_{IN} = V_{INmin}$ to $V_{INmax}$ at $I_{OUT} = I_{OUTmax}$			3	mV
	Turn-on time	$I_{OUT}$ = 0, $C_L$ = 1 $\mu F$ (within 10% of $V_{OUT})$			100	μs
	Wake-up time	Full load capability			10	μs
		f < 10 kHz	50			
	Ripple rejection	10 kHz < f < 100 kHz	40			dB
		f = 1 MHz	30			uD
		$V_{IN} = V_{OUT} + 1 V$ , $I_O = I_{MAX}$				
		On mode, I <sub>OUT</sub> = 0			70	
		On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			170	
	Ground current	Low-power mode, $I_{OUT} = 0$			17	μA
		Low-power mode, $I_{OUT} = 5$ mA			20	
		Off mode at 55°C			1	
V <sub>DO</sub>	Dropout voltage <sup>(1)</sup>	On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			250	mV

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(1) For nominal output voltage

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PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Transient load regulation <sup>(2)</sup>	I <sub>LOAD</sub> : Ι <sub>MIN</sub> – Ι <sub>MAX</sub> Slew: 40 mA/μs	-40		40	mV
Transient line nem detien	V <sub>IN</sub> drops 500 mV			10	
Transient line regulation	Slew: 40 mV/µs			10	mV
Overshoot	Softstart			3%	
	Default in off mode	250	320	450	Ω
Pulldown resistance	Configurable as HighZ in off mode	100			MΩ

(2) Transient load regulation is always included in the overall accuracy of the selected output voltage option. For voltage levels that have a tighter output voltage specification than the transient load regulation, follow the output voltage specification.

#### VPLL LOW DROPOUT REGULATOR

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IN</sub>	Input voltage		2.7	3.6	4.5	V
	Output voltage including all		0.97	1.0	1.03	
,	variations (line and load		1.164	1.2	1.236	V
V <sub>OUT</sub>	regulations, line and load transients, temperature, and		1.261	1.3	1.339	V
	process)		1.746	1.8	1.854	
	Rated output current	On mode			40	mA
OUT	Rated output current	Low-power mode			5	IIIA
	DC load regulation	On mode: $0 < I_O < I_{MAX}$			20	mV
	DC line regulation	On mode, V <sub>IN</sub> = V <sub>INmin</sub> to V <sub>INmax</sub> at I <sub>OUT</sub> = I <sub>OUTmax</sub>			3	mV
	Turn-on time	$I_{OUT}$ = 0, $C_L$ = 1 $\mu F$ (within 10% of $V_{OUT})$			100	μs
	Wake-up time	Full load capability			10	μs
		f < 10 kHz	50			
	Ripple rejection	10 kHz < f < 100 kHz	40			dB
	Ripple rejection	f = 1 MHz	30			aв
		$V_{IN} = V_{OUT} + 1 V$ , $I_O = I_{MAX}$				
		On mode, I <sub>OUT</sub> = 0			70	
		On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			110	
	Ground current	Low-power mode, $I_{OUT} = 0$			15	μA
		Low-power mode, I <sub>OUT</sub> = 1 mA			16	P
		Off mode at 55°C			1	
V <sub>DO</sub>	Dropout voltage <sup>(1)</sup>	On mode, I <sub>OUT</sub> = I <sub>OUTmax</sub>			250	mV
	Transient load regulation <sup>(2)</sup>	I <sub>LOAD</sub> : I <sub>MIN</sub> – I <sub>MAX</sub> Slew: 60 mA/μs	-40		40	mV
	-	V <sub>IN</sub> drops 500 mV				
	Transient line regulation	Slew: 40 mV/µs			10	mV
	Overshoot	Softstart			3%	
	Pulldown resistance	Default in off mode	250	320	450	Ω

(1) For nominal output voltage

(2) Transient load regulation is always included in the overall accuracy of the selected output voltage option. For voltage levels that have a tighter output voltage specification than the transient load regulation, follow the output voltage specification.

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#### **INTERNAL LDOS**

Internal LDOs (except USBCP, which is a boost) are described in following table.

NAME	USAGE	TYPE	VOLTAGE RANGE (V)	DEFAULT VOLTAGE (V)	MAXIMUM CURRENT
VINTANA1	Internal	LDO	1.5	1.5	50 mA
VINTANA2	Internal	LDO	2.5, 2.75	2.75	250 mA
VINTDIG	Internal	LDO	1.5	1.5	100 mA
USBCP	Internal	Charge pump	5	5	100 mA
VUSB1V5	Internal	LDO	1.5	1.5	30 mA
VUSB1V8	Internal	LDO	1.8	1.8	30 mA
VUSB3V1	Internal	LDO	3.1	3.1	14 mA
VRRTC	Internal	LDO	1.5	1.5	30 mA
VBRTC	Internal	LDO	1.3	1.3	100 μA

#### VOLTAGE REFERENCES

PARAMETER	TEST CONDITONS	MIN	ТҮР	MAX	UNIT
Internal bandgap reference voltage	On mode, measured through TESTV terminal	1.272	1.285	1.298	V
Reference voltage (V <sub>REF</sub> terminal)	On mode	0.7425	0.75	0.7575	V
Retention mode reference	On mode	0.492	0.5	0.508	V
I <sub>REF</sub> NMOS sink		0.9	1.0	1.1	μA
	Bandgap			25	
	I <sub>REF</sub> block			20	
Ground current	Preregulator			15	μA
	V <sub>REF</sub> buffer			10	μ
	Retention reference buffer			10	
Output spot noise	100 Hz			1	μV/√Hz
A-weighted noise (rms)			200		nV (rms)
P-weighted noise (rms)			150		nV (rms)
Integrated noise	20 Hz to 100 kHz		2.2		μV
I <sub>BIAS</sub> trim bit LSB				0.1	μA
Ripple rejection	< 1 MHz from VBAT	60			dB
Start-up time				1	ms

## **BACKUP BATTERY CHARGER**

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PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
VBACKUP to MADC input attenuation	VBACKUP from 1.8 V to 3.3 V		0.33		V/V

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PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
	VBACKUP = 2.8 V, BBCHEN = 1, BBISEL = 00	10	25	45	μA
	VBACKUP = 2.8 V, BBCHEN = 1, BBISEL = 01	105	150	270	μΑ
	VBACKUP = 2.8 V, BBCHEN = 1, BBISEL = 10	350	500	900	μΑ
Backup battery charging current	VBACKUP = 2.8 V, BBCHEN = 1, BBISEL = 11	0.7	1.0	1.8	mA
	VBACKUP = 0 V, BBCHEN = 1, BBISEL = 00	17.5	25	45	μΑ
	VBACKUP = 0 V, BBCHEN = 1, BBISEL = 01	105	150	270	μΑ
	VBACKUP = 0 V, BBCHEN = 1, BBISEL = 10	350	500	900	μA
-	VBACKUP = 0 V, BBCHEN = 1, BBISEL = 11	0.7	1.0	1.8	mA
	IVBACKUP = $-10 \mu A$ , BBSEL = $00$	2.4	2.5	2.6	V
End backup battery charging	IVBACKUP = $-10 \mu A$ , BBSEL = $01$	2.9	3.0	3.1	V
voltage:	IVBACKUP = $-10 \mu A$ , BBSEL = $10$	3.0	3.1	3.2	V
VBBCHGEND	IVBACKUP = $-10 \mu A$ , BBSEL = $11$	3.1	3.2	3.3	V

#### BATTERY THRESHOLD LEVELS<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Main battery charged threshold - VMBCH	Measured on VBAT terminal, VMBCH_SEL = 00	3.14	3.2	3.3	V
	Measured on VBAT terminal, VMBCH_SEL = 01	3.04	3.1	3.2	V
	Measured on VBAT terminal, VMBCH_SEL = 10	3.24	3.3	3.4	V
	Measured on VBAT terminal, VMBCH_SEL = 11	3.34	3.4	3.5	V
Main battery low threshold VMBLO	VBACKUP = 3.2 V, measured on VBAT terminal (monitored on terminal ONNOFF)	2.55	2.7	2.8	V
Main battery high threshold VMBHI	Measured on terminal VBAT	2.5	2.65	3.0	V
Batteries not	Measured on terminal VBAT	1.6	1.8	2.6	V
present threshold VBNPR	Measured on terminal VBAT in slave mode	1.95	2.1	2.6	V

(1) Backup ball must always be tied to ground.

#### POWER CONSUMPTION

The typical power consumption is obtained in the nominal operating conditions and with the TPS65921 standalone.

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## TPS65921

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МС	DDE	DESCRIPTION	TYPICAL CONSUMPTION	
		Only the RTC date is maintained with a	VBAT not present and Quartz present	2.25 μA × 3.2 V = 7.2 μW
	BACKUP	couple of registers in the backup domain. No main source is connected. The consumption is on the backup battery.	VBAT not present and Quartz not present (only running with RC32k)	(2.25 + 7) μA × 3.2 V = 29.6 μW
C021 boot mode	WAIT-ON	The phone is apparently off for the user, a main battery is present and well-charged. The RTC registers, registers in backup domain are maintained. The wak-eup capabilities (like the PWRON button) are available.	VBAT = 3.8 V and Quartz present	64 μA x 3.8 V = 243.2 μW
	ACTIVE No Load HFCLK = 26 MHz	Subsystem is powered by the main battery. All supplies are enabled with no external		(2995 + 433) μA × 3.8 V = 13026 μW
H	ACTIVE No Load HFCLK = 38.4 MHz	load, internal reset is released, and the associated processor is running. USB intertupt handler consumes 433 μA (typ).	VBAT = 3.8 V	(3879 + 433) μA × 3.8 V = 16386 μW
	SLEEP No Load	The main battery powers subsystem. Selected supplies are enabled but in low-consumption mode and associated processor is in low-power mode.	VBAT = 3.8 V	492 μA × 3.8 V = 1870 μW

#### **USB CHARGE PUMP**

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IN</sub>	Input voltage	On mode: V <sub>IN</sub> = VBAT	2.7	3.6	4.5	V
Vo	Output voltage		4.625	5.0	5.25	V
		VBAT > 3 V at VBUS	0		100	
I <sub>load</sub>	ad Rated output current	2.7 V < VBAT < 3 V, at VBUS	0		50	mA
	Efficiency	$I_{LOAD} = 100 \text{ mA}, \text{ VBAT} = 3.6 \text{ V}$		55%		
	Setting time	$I_{LOADmax/2}$ to $I_{LOADmax}$ in 5 $\mu$ s		100	400	μs
	Start-up time				3	ms
	Short-circuit limitation current		250	350	450	mA
	DC load regulation	I <sub>LOADmin</sub> to I <sub>LOADmax</sub>		250	500	mV
	DC line regulation	3.0 V to VBAT <sub>max</sub>		250	050 050	m)/
	DC line regulation	$I_{LOAD} = 100 \text{ mA}$		250	350	mV
		I <sub>VBUS_5Vmax/2</sub> – IVBUS_5Vmax		300	350	
	Transient load regulation	50 μs, C = 2 × 4.7 μF				mV
		$0 - I_{VBUS_{5}Vmax/2}, 50 \ \mu s, C = 2 \times 4.7 \ \mu F$			350	
	Transient line regulation	VBAT <sub>min</sub> to VBAT <sub>max</sub> in 50 $\mu$ s, C = 2 × 4.7 $\mu$ F		300	350	mV

#### HOT-DIE DETECTION AND THERMAL SHUTDOWN

PARAMETER	THRESHOLD (NOMINAL) <sup>(1)</sup>		
Thermal hot-die selection THERM_HDSEL[1:0]	Threshold (nominal) <sup>(1)</sup>		
	Rising temp: 120°C		
00 (1st hot-die threshold)	Falling temp: 111°C		
	Rising temp: 130°C		
01 (2nd hot-die threshold)	Falling temp: 121°C		

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(1) The minimum/maximum range is ±5%

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PARAMETER	THRESHOLD (NOMINAL) <sup>(1)</sup>
10 (2rd hat die threshold)	Rising temp: 140°C
10 (3rd hot-die threshold)	Falling temp: 131°C
11 (4th hot-die threshold)	Not used
The second sheet down a stable	Threshold (nominal) <sup>(1)</sup> - Rising temp: 150°C
Thermal shutdown enable	Threshold (nominal) <sup>(1)</sup> - Falling temp: 140°C

#### USB

#### LS/FS SINGLE-ENDED RECEIVERS

	PARAMETER	COMMENTS	MIN	ТҮР	MAX	UNIT
		USB Single-Ended Re	eceivers			
Skew between VP and VM	SKWVP_VM	Driver outputs unloaded	-2	0	2	ns
Single-ended hysteresis	V <sub>SE_HYS</sub>		50			mV
High (driven)	V <sub>IH</sub>		2			V
Low	V <sub>IL</sub>				0.8	V
Switching threshold	V <sub>TH</sub>		0.8		2	V

#### LS/FS DIFFERENTIAL RECEIVER

PARAMETER		COMMENTS	MIN	TYP	MAX	UNIT
Differential input sensitivity	VDI	Ref. USB2.0	200			mV
Differential common mode range	VCM	Ref. USB2.0	0.8		2.5	V

#### LS/FS TRANSMITTER

PARAMETER		COMMENTS	MIN	TYP	MAX	UNIT
Low	VOL	Ref. USB2.0	0		300	mV
High (driven)	VOH	Ref. USB2.0	2.8		3.6	V
Output signal crossover voltage	VCRS	Ref. USB2.0, covered by eye diagram	1.3		2.0	V
Rise time	TFR		75		300	ns
Fall time	TFF	Ref. USB2.0, covered by eye diagram	75		300	ns
Differential rise and fall time matching	TFRFM		80%		125%	
Low-speed data rate	TFDRATE	Ref. USB2.0, covered by eye diagram	1.4775		1.5225	Mbps
Source jitter total (including frequency tolerance):						
- To next transition	TDJ1	Ref. USB2.0, covered by eye diagram	-25		25	ns
- For paired transitions	TDJ2		-10		10	
Source SE0 interval of EOP	TFEOPT	Ref. USB2.0, covered by eye diagram	1.25		1.5	μs
Downstream eye diagram		Ref. USB2.0, covered by eye diagram				
Differential common mode range	VCM	Ref. USB2.0	0.8		2.5	V

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#### **FS TRANSMITTER**

PARAMETER		COMMENTS	MIN	TYP	MAX	UNIT
Low	VOL	Ref. USB2.0	0		300	mV
High (driven)	VOH	Ref. USB2.0	2.8		3.6	V
Output signal crossover voltage	VCRS	Ref. USB2.0, covered by eye diagram	1.3		2.0	V
Rise time	TFR	Ref. USB2.0	4		20	ns
Fall time	TFF	Ref. USB2.0	4		20	ns
Differential rise and fall time matching	TFRFM	Ref. USB2.0, covered by eye diagram	90%		111.11%	
Driver output resistance	ZDRV	Ref. USB2.0	28		44	Ω
Full-speed data rate	TFDRATE	Ref. USB2.0, covered by eye diagram	11.97		12.03	Mbps
Source jitter total (including frequency tolerance):						
- To next transition	TDJ1	Ref. USB2.0, covered by eye diagram	-2		2	ns
- For paired transitions	TDJ2		-1		1	
Source SE0 interval of EOP	TFEOPT	Ref. USB2.0, covered by eye diagram	160		175	ns
Downstream eye diagram		Ref. USB2.0, covered by eye diagram				
Upstream eye diagram						

#### HS DIFFERENTIAL RECEIVER

PARAMETER		COMMENTS	MIN	ТҮР	MAX	UNIT
High-speed squelch detection threshold (differential signal amplitude)	VHSSQ	Ref. USB2.0	100		150	mV
High-speed disconnect detection threshold (differential signal amplitude)	VHSDSC	Ref. USB2.0	525		625	V
High-speed differential input signaling levels		Ref. USB2.0, specified by eye pattern templates				mV
High-speed data signaling common mode voltage range (guidelines for receiver)	VHSCM	Ref. USB2.0	-50		600	mV
Receiver jitter tolerance		Ref. USB2.0, specified by eye pattern templates			150	ps

#### **HS TRANSMITTER**

PARAMETER		COMMENTS	MIN	ТҮР	MAX	UNIT
High-speed idle level	VHSOI	Ref. USB2.0	-10		10	mV
High-speed data signaling high	VHSOH	Ref. USB2.0	360		440	mV
High-speed data signaling low	VHSOL	Ref. USB2.0	-10		10	mV
Chirp J level (differential voltage)	VCHIRPJ	Ref. USB2.0	700		1100	mV
Chirp K level (differential voltage)	VCHIRPK	Ref. USB2.0	-825		-500	mV
Rise Time (10% – 90%)	THSR	Ref. USB2.0, covered by eye diagram	500			
Fall time (10% – 90%)	THSR	Ref. USB2.0, covered by eye diagram	500			





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PARAMETER		COMMENTS	MIN	TYP	MAX	UNIT
Driver output resistance (which also serves as high-speed termination)	ZHSDRV	Ref. USB2.0	40.5		49.5	Ω
High-speed data range	THSDRAT	Ref. USB2.0, covered by eye diagram	479.76		480.24	Mbps
Data source jitter		Ref. USB2.0, covered by eye diagram				
Downstream eye diagram		Ref. USB2.0, covered by eye diagram				
Upstream eye diagram		Ref. USB2.0, covered by eye diagram				

#### UART TRANSCEIVER

	PARAMETER		MAX	UNIT
t <sub>PH_DP_CON</sub>	Phone D+ connect time	100		ms
t <sub>PH_DISC_DET</sub>	Phone D+ disconnect time	150		ms
f <sub>UART_DFLT</sub>	Default UART signaling rate (typical rate)		9600	bps

PARAMETER		COMMENTS	MIN	TYP	MAX	UNIT			
UART Transmitter CEA-2011									
Phone UART edge rates	t <sub>PH_UART_EDG</sub>	PH_UART_EDG DP_PULLDOWN asserted			1	Ms			
Serial interface output high	V <sub>OH_SER</sub>	ISOURCE = 4 mA	2.4	3.3	3.6	V			
Serial interface output low	V <sub>OL_SER</sub>	ISINK = -4 mA	0	0.1	0.4	V			
		UART Receiver CEA	-2011						
Serial interface input high	V <sub>IH_SER</sub>	DP_PULLDOWN asserted	2.0			V			
Serial interface input low	V <sub>IL_SER</sub>	DP_PULLDOWN asserted			0.8	V			
Switching threshold	V <sub>TH</sub>		0.8		2.0	V			

#### PULLUP/PULLDOWN RESISTORS

PARAMETER		COMMENTS	MIN	ТҮР	MAX	UNIT
		Pullup Resistor	S		•	•
Bus pullup resistor on upstream port (idle bus)	R <sub>PUI</sub>	Bus idle	0.9	1.1	1.575	1.0
Bus pullup resistor on upstream port (receiving)	R <sub>PUA</sub>	Bus driven/driver's outputs unloaded	1.425	2.2	3.09	kΩ
High (floating)	V <sub>IHZ</sub>	Pullups/pulldowns on both DP and DM lines	2.7		3.6	V
Phone D+ pullup voltage	V <sub>PH_DP_UP</sub>	Driver's outputs unloaded	3.0	3.3	3.6	V
		Pulldown Resisto	ors			•
Phone D+/- pulldown	R <sub>PH_DP_DWN</sub>	Driver's outputs unloaded	14.25	18	24.8	kΩ
High (floating)	V <sub>IHZ</sub>	Pullups/pulldowns on both DP and DM lines	2.7		3.6	V
		D+/- Data line				•
Upstream facing port	C <sub>INUB</sub>	[1.0]		22	75	pF
On-the-go device leakage	V <sub>OTG_DATA_LK</sub> g	[2]			0.342	V
Input impedance exclusive of pullup/pulldown	Z <sub>INP</sub>	Driver's outputs unloaded	300			kΩ

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#### OTG VBUS

PARAMETER		COMMENTS	MIN	ТҮР	MAX	UNIT
		VBUS Wakeup Comp	arator			
VBUS wake-up delay	DEL <sub>VBUS_WK_</sub>	-VBUS_WK_			15	μs
	-!	VBUS Comparato	rs		+	
A-device session valid	V <sub>A_SESS_VLD</sub>		0.8	1.1	1.4	V
A-device V <sub>BUS</sub> valid	V <sub>A_VBUS_VLD</sub>		4.4	4.5	4.625	V
B-device session end	V <sub>B_SESS_END</sub>		0.2	0.5	0.8	V
B-device session valid	V <sub>B_SESS_VLD</sub>		2.1	2.4	2.7	V
		VBUS Line				
A-device VBUS input impedance to ground	R <sub>A_BUS_IN</sub>	SRP (VBUS pulsing) capable A-device not driving VBUS	13.77		100	kΩ
B-device VBUS SRP pulldown	R <sub>B_SRP_DWN</sub>	5.25 V / 8 mA, pullup voltage = 3 V	0.656	10		kΩ
B-device VBUS SRP pullup	R <sub>B_SRP_UP</sub>	(5.25 V - 3 V) / 8 mA, pullup voltage = 3 V	0.85	1.3	1.75	kΩ
B-device VBUS SRP rise time maximum for OTG-A communication	t <sub>RISE_SRP_UP_</sub> MAX	0 to 2.1 V with < 13 $\mu$ F load			34	ms
B-device VBUS SRP rise time minimum for standard host connection	t <sub>RISE_SRP_UP_</sub> MIN	0.8 to 2.0 V with > 97 $\mu\text{F}$ load	46			ms

#### OTG ID

PARAMETER		COMMENTS	MIN	ТҮР	MAX	UNIT				
	VBUS Wakeup Comparator									
ID wake-up comparator	R <sub>ID_WK_UP</sub>	Wakeup when ID shorted to ground.	30		100	kΩ				
	ID C	comparators — ID External Resis	tors Specific	ations						
ID ground comparator	R <sub>ID_GND</sub>	DID_GND interrupt 4 20		20	25	kΩ				
ID Float comparator	R <sub>ID_FLOAT</sub>	ID_FLOAT interrupt	200		500	kΩ				
		ID Line								
Phone I <sub>D</sub> pullup to $V_{PH_ID_UP}$	R <sub>PH_ID_UP</sub>	ID unloaded (VRUSB)	70	90	286	kΩ				
Phone I <sub>D</sub> pullup voltage			2.5		3.2	V				
ID line maximum voltage					5.25	V				

#### **USB CHARGER DETECTION**

USB Charger Detection Debounce Time									
REQUIREMENT	PARAMET ER	NB CLOCK	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT		
Minimum 10 ms	DEBVBUS_ TIME	448	ACTIVE/SLEEP mode <sup>(1)</sup>	13.7		13.7	ms		
Minimum 20 ms	DEBUSBC HG_TIME	896	ACTIVE/SLEEP mode <sup>(1)</sup>	27.3		27.3	ms		

(1) When clocked only on CK32K Xtal oscillator.

#### Table 4. Voltages

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNIT	REF
Logic Threshold	V <sub>LGC</sub>		0.8	2.0	V	1.4.4
D+ Source Voltage	V <sub>DP_SRC</sub>	Output current > 250 μA	0.5	0.675	V	



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Table 4	Voltages	(continued)
	Tonages	(continued)

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNIT	REF
Data Detect Voltage	V <sub>DAT_REF</sub>		0.25	0.4	V	
Data Line Leakage Voltage	V <sub>DAT_LKG</sub>		0	3.6	V	3.9

#### Table 5. Currents

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNIT	REF
Portable Device Current from Charging Host Port during chirp	I <sub>DEV_HCHG_CHRP</sub>			710	mA	3.6.2
Data Contact Detect Current Source	I <sub>DP_SRC</sub>		7	13	μΑ	
D- Sink Current	I <sub>DM_SINK</sub>		50	150	μA	

#### Table 6. Resistances

D+ pulldown resistance	R <sub>DP_DWN</sub>	14.25	24.8	kΩ
D- pulldown resistance	R <sub>DM_DWN</sub>	14.25	24.8	kΩ

#### Table 7. USB Charger Detection (Wait and Debounce Timing)

	USB Charger Detection (Wait and Debounce Timing)									
Requirement	PARAMET ER	NB CLOCK	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT			
Minimum 200 us	D+ Current source on-time TIDP_SRC_ ON	8	ACTIVE/SLEEP mode <sup>(1)</sup>	244.1		244.1	ha			
Minimum 40 ms	D+ Voltage source on-time TVDP_SRC _ON	1792	ACTIVE/SLEEP mode <sup>(1)</sup>	54.7		54.7	ms			
Minimum 40 ms	D+ Voltage source off to high current TVDP_SRC _HICRNT	1792	ACTIVE/SLEEP mode <sup>(1)</sup>	54.7		54.7	ms			
Minimum 2 s	DATA_CON TACT_DET ECT Timeout TDCD_TIM EOUT	89600	ACTIVE/SLEEP mode <sup>(1)</sup>	2.73		2.73	S			

(1) When clocked only on CK32K Xtal oscillator. Note: LS Device mode not supported

#### MADC

PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNIT
Resolution			10		Bit
Input dynamic range for external input ADCIN0		0		1.5	V
MADC voltage reference			1.5		V
Differential nonlinearity		-1		1	LSB
Integral nonlinearity	Best fitting	-2		2	LSB
Offset	Best fitting	-28.5		28.5	mV

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Input bias		1		μΑ
Input capacitor CBANK			10	pF
Input current leakage			1	μA

#### MADC Analog Input Range and Prescaler Ratio

MADC CHANNEL	INT/EXT	ANALOG INP	UT RANGE (V)		PRES	CALER	
		MIN	MAX	OUTPUT	RANGE (V)	DIVIDER	NOTE
		MIN	MAX	MIN	MAX	RATIO	NOTE
ADCIN0: General- purpose input <sup>(1)</sup>	External	0.0	1.5	N/A	N/A	1	No prescaler
ADCIN1:7 Reserved	Internal	N/A	N/A	N/A	N/A	N/A	Not used
ADCIN8: VBUS Voltage (VBUS)	Internal						Prescaler in USB subchip.
		0.0	6.5	0.0	1.5	3/14	Rdivider = $(6 \times 2.76 \text{ k}\Omega)/(28 \times 2.76 \text{ k}\Omega)$ (typ) <sup>(2)</sup>
ADCIN9: Backup battery voltage (BKBAT)	Internal	1.8	3.3	0.6	1.1	1/3	Prescaler integrated Rdivider = 212 $k\Omega/636 k\Omega$ $(typ)^{(2)}$
ADCIN10:11 Reserved	Internal	N/A	N/A	N/A	N/A	N/A	
ADCIN12: Main battery voltage	Internal						Prescaler integrated
(VBAT)		2.7	4.7	0.675	1.175	0.25	Rdivider = 9.85 $k\Omega/(4 \times 9.85 \ k\Omega) \ (typ)^{(3)}$
ADCIN13:15 Reserved	Internal	N/A	N/A	N/A	N/A	N/A	

General-purpose input has to be tied to ground when TPS65921 internal power supply (VINTANA1) is off. (1)

(2) (3) Tolerance for resistors-type (PL\_VHSR): ±19% Tolerance for resistors-type (PL\_HR): ±12%

The table below summarizes the sequence conversion timing characteristics. Figure 5 shows one conversion sequence general timing diagram.

PARAMETER	COMMENTS	MIN	ТҮР	MAX	UNIT
F	Running frequency		1		MHz
T = 1/F	Clock period		1		μS
N	Number of analog inputs to convert in a single sequence	0		16	
Tstart	SW1, SW2, or USB asynchronous request or real-time STARTADC request	3		4	μs

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Tsettling time	Settling time to wait before sampling a stable analog input (capacitor bank charge time)				
	Tsettling is calculated from the max((Rs + Ron)*Cbank) of all possible input sources (internal or external). Ron is the resistance of the selection analog input switches (5 kOHM). This time is software programmable by OCP register; default value is 12 µs.	5	12	260	μs
Tstartsar	The successive approximation registers ADC start time		1		μs
Tadc time	The successive approximation registers ADC conversion time		10		μS
Tcapture time	Tcapture time is the conversion result capture time.		2		μs
Tstop		1		2	μS
Full Conversion Sequence Time	Only one channel (N = 1) $^{(1)}$	22		39	μS
	All channels <sup>(2)</sup>	352		624	
Conversion Sequence Time	Without Tstart and Tstop: Only one channel $(N = 1)^{(1)}$	18		33	μs
	Without Tstart and Tstop: All channels <sup>(1)</sup>	288		528	
STARTADC pulse duration	STARTADC period is T	0.33			μS

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General-purpose input ADCIN0 must be tied to ground when TPS65921 internal power supplies (VINTANA1) is off.
 Total Sequence Conversion Time General Formula: Tstart + N x (1 + Tsettling + Tadc + Tcapture) + Tstop.

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This table is illustrated in Figure 5. The Busy parameter indicates that a conversion sequence is running, and the channel N result register parameter corresponds to the result register of RT/GP selected channel.

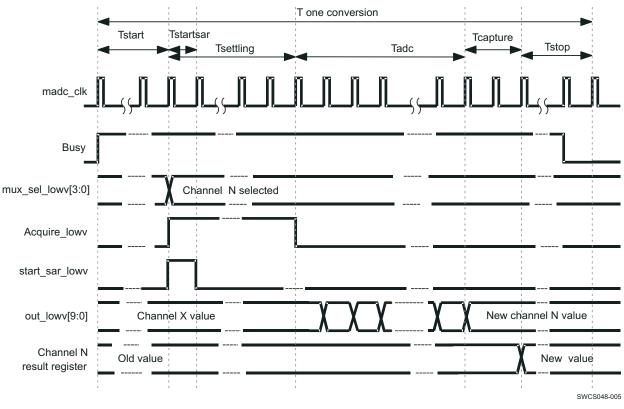


Figure 5. One Conversion Sequence General Timing Diagram

#### **MADC** Power Consumption

PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Power on consumption	Running frequency f = 1 MHz		1 (1)		mA
Power down consumption			1		μΑ

(1) The consumption is given in stand-alone mode.

## **TPS65921 INTERFACE TARGET FREQUENCIES**

Table below assumes testing over the recommended operating conditions.

I/O INTERFACE	INTERFAC	INTERFACE DESIGNATION		
			1.5 V	
SmartReflex I2C		Slave high-speed mode	3.6 Mbps	
General-purpose I2C	I <sup>2</sup> C Interface	Slave fast-speed mode	400 kbps	
		Slave standard mode	100 kbps	
		High speed	480 Mbps	
USB	USB	Full speed	12 Mbps	
		Low speed	1.5 Mbps	
	Real/View® ICE tool		30 MHz	
JTAG	XDS560 and XDS510 tools		30 MHz	
	Lauterbach™ tool		30 MHz	

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#### www.ti.com I<sup>2</sup>C Timing

The TPS65921 provides two I<sup>2</sup>C HS slave interfaces (one for general-purpose and one for SmartReflex). These interfaces support the standard mode (100 kbps), fast mode (400 kbps), and HS mode (3.5 Mbps). The general-purpose I<sup>2</sup>C module embeds four different slave hard-coded addresses (ID1 = 48h, ID2 = 49h, ID3 = 4Ah, and ID4 = 4Bh). The SmartReflex I<sup>2</sup>C module uses one slave hard-coded address (ID5). The master mode is not supported.

 Table 8 and Table 9 assume testing over the recommended operating conditions.

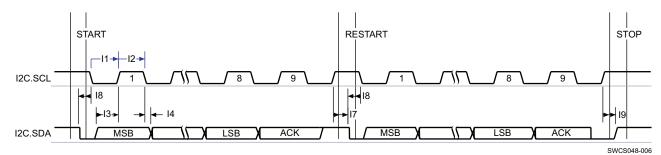


Figure 6.	I <sup>2</sup> C Interface—	-Transmit and	<b>Receive in</b>	Slave Mode
-----------	-----------------------------	---------------	-------------------	------------

<b>C</b>	Iak	ble 8. I-C Interface I Ir	ning Requirement	1.5					
NO.	PA	RAMETER	MIN	MAX	UNIT				
Slave High-Speed Mode									
13	t <sub>su(SDA-SCLH)</sub>	Setup time, SDA valid to SCL high	10		ns				
14	t <sub>h(SCLL</sub> -SDA)	Hold time, SDA valid from SCL low	0	70	ns				
17	t <sub>su(SCLH-SDAL)</sub>	Setup time, SCL high to SDA low	160		ns				
18	t <sub>h(SDAL-SCLL)</sub>	Hold time, SCL low from SDA low	160		ns				
19	t <sub>su(SDAH-SCLH)</sub>	Setup time, SDA high to SCL high	160		ns				
		Slave Fast-S	peed Mode		•				
13	t <sub>su(SDA-SCLH)</sub>	Setup time, SDA valid to SCL high	100		ns				
14	t <sub>h(SCLL</sub> -SDA)	Hold time, SDA valid from SCL low	0	0.9	ns				
17	t <sub>su(SCLH-SDAL)</sub>	Setup time, SCL high to SDA low	0.6		ns				
18	t <sub>h(SDAL-SCLL)</sub>	Hold time, SCL low from SDA low	0.6		ns				
19	t <sub>su(SDAH-SCLH)</sub>	Setup time, SDA high to SCL high	0.6		ns				
		Slave Stand	ard Mode		·				
13	t <sub>su(SDA-SCLH)</sub>	Setup time, SDA valid to SCL high	250		ns				
14	t <sub>h(SCLL</sub> -SDA)	Hold time, SDA valid from SCL low	0		ns				
17	t <sub>su(SCLH-SDAL)</sub>	Setup time, SCL high to SDA low	4.7		ns				

Table 8. I <sup>2</sup> C Interface Timing Requirements <sup>(1)(</sup>	)(2)
---	------

 (1) The input timing requirements are given by considering a rising or falling time of: 80 ns in high-speed mode (3.4 Mbits/s) 300 ns in fast-speed mode (400 Kbits/s) 1000 ns in standard mode (100 Kbits/s)

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 (2) SDA is equal to I2C.SR.SDA or I2C.CNTL.SDA SCL is equal to I2C.SR.SCL or I2C.CNTL.SCL

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Table 8. I <sup>2</sup> C Interface Timing Requirements <sup>(1)(2)</sup> (continued)						
18	t <sub>h(SDAL-SCLL)</sub>	Hold time, SCL low from SDA low	4		ns	
19	t <sub>su(SDAH-SCLH)</sub>	Setup time, SDA high to SCL high	4		ns	

#### Table 9. I<sup>2</sup>C Interface Switching Requirements<sup>(1)(2)</sup>

NO.		PARAMETER		MAX	UNIT				
Slave High-speed Mode									
11	t <sub>w(SCLL)</sub>	Pulse duration, SCL low	160		ns				
12	t <sub>w(SCLH)</sub>	t <sub>w(SCLH)</sub> Pulse duration, SCL high			ns				
		Slave Fast-spe	ed Mode	•	•				
11	t <sub>w(SCLL)</sub>	Pulse duration, SCL low	1.3		ns				
12	t <sub>w(SCLH)</sub>	t <sub>w(SCLH)</sub> Pulse duration, SCL high			ns				
		Slave Standar	rd Mode						
11	t <sub>w(SCLL)</sub>	Pulse duration, SCL low	4.7		ns				
12	t <sub>w(SCLH)</sub>	Pulse duration, SCL high	4		ns				

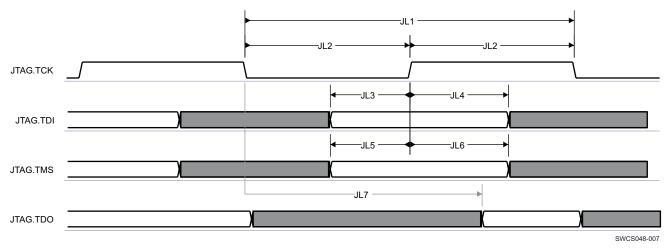
The capacitive load is equivalent to: (1) 100 pF in high-speed mode (3.4 Mbits/s)

400 pF in fast-speed mode (400 Kbits/s) 400 pF in standard mode (100 Kbits/s)

SDA is equal to I2C.SR.SDA or I2C.CNTL.SDA (2) SCL is equal to I2C.SR.SCL or I2C.CNTL.SCL

#### **JTAG INTERFACES**

Table 10 and Table 11 assume testing over the recommended operating conditions.





The input timing requirements are given by considering a rising or falling edge of 7 ns.



#### **JTAG Interface Timing Requirements**

NO.	PA	PARAMETER		MAX	UNIT				
Clock									
JL1	t <sub>c(TCK)</sub> Cycle time, JTAG.TCK period		30		ns				
JL2	t <sub>w(TCK)</sub>			0.52 × P	ns				
		Read Ti	ming	1					
JL3	3 t <sub>su(TDIV-TCKH)</sub> Setup time, JTAG.TDI valid before JTAG.TCK high		8		ns				
JL4	t <sub>h(TDIV-TCKH)</sub>	Hold time, JTAG.TDI valid after JTAG.TCK high	5		ns				
JL5	t <sub>su(TMSV-TCKH)</sub>	Setup time, JTAG.TMS valid before JTAG.TCK high			ns				
JL6	t <sub>h(TMSV-TCKH)</sub>	Hold time, JTAG.TMS valid after JTAG.TCK high	5		ns				

#### Table 10. JTAG Interface Timing Requirements

(1) P = JTAG.TCK clock period

The capacitive load is equivalent to 35 pF.

#### **JTAG Interface Switching Characteristics**

#### Table 11. JTAG Interface Switching Characteristics

NO.	PARA	METER	MIN	MAX	UNIT			
Write Timing								
JL7	t <sub>d(TCK-TDOV))</sub>	Delay time, JTAG, TCK active edge to JTAG.TDO valid	0	14	ns			

NO.	PARAMETER		MIN	MAX	UNIT				
Clock									
JL1	t <sub>c(TCK)</sub>	Cycle time, JTAG.TCK period	30		ns				
JL2	t <sub>w(TCK)</sub> Pulse duration, JTAG.TCK high c low <sup>(1)</sup>		0.48 × P	0.52 × P	ns				
Read Timing									
JL3	t <sub>su(TDIV-TCKH)</sub>	Setup time, JTAG.TDI valid before JTAG.TCK high	8		ns				
JL4	t <sub>h(TDIV-TCKH)</sub>	Hold time, JTAG.TDI valid after JTAG.TCK high	5		ns				
JL5	t <sub>su(TMSV-TCKH)</sub>	Setup time, JTAG.TMS valid before JTAG.TCK high	8		ns				

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#### (1) P = JTAG.TCK clock period

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	JL6	t <sub>h</sub> (TMSV-TCKH)	Hold time, JTAG.TMS valid after JTAG.TCK high	5		ns
--	-----	----------------------------	---	---	--	----

#### **Debouncing Time**

Debounce times are listed in Table 12.

#### Table 12. Debouncing Time

DEBOUNCING FUNCTIONS	BLOCK	PROGRAMMABLE	DEBOUNCING TIME	DEFAULT
Main battery charged threshold (<3.2 V)	Battery monitoring	No	580 μs	580 μs
Main battery low threshold detection (<2.7 V)		No	60 µs	60 µs
Main battery plug detection		No	60 µs	60 µs
Debouncing functions interrupt generation debounce	POWER	No	125.6 μs	125.6 μs
Plug/unplug detection VBUS <sup>(1)</sup>	USB	Yes	0 to 250 ms (32/32768-second stgif)	30 ms
Plug/unplug detection ID <sup>(2)</sup>	USB	Yes	0 to 250 ms (32/32768-second stgif)	50 ms
Debouncing functions interrupt generation debounce for VBUS and ID <sup>(3)</sup>	POWER	Yes	0 to 250 ms	70 ms
Hot-die detection	Thermistor	No	60 μs	60 μs
Thermal shutdown detection		No	60 µs	60 µs
PWRON <sup>(4)</sup>	Start/stop button	No	31.25 ms	31.25 ms
NRESWARM	Button reset	No	60 μs	60 μs
MMC1/2 (plug/unplug)	GPIO	Yes	0 or 28 ms ± 2 ms	0 ms

(1)

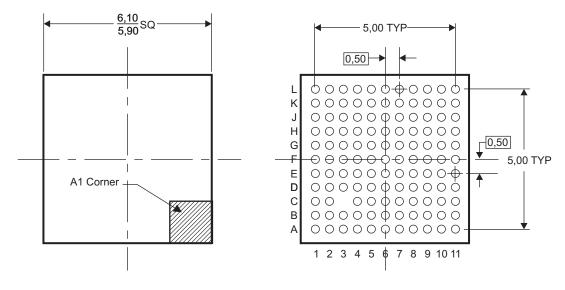
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Programmable in the VBUS\_DEBOUNCE register. Programmable in the ID\_DEBOUNCE register. Programmable in the RESERVED\_E[2:0] CFG\_VBUSDEB register The PWRON signal is debounced 1024 × CLK32K (maximum 1026 × CLK32K) falling edge in master mode. (2) (3) (4)

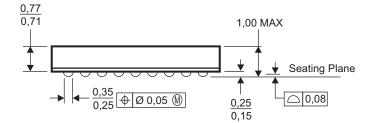


#### **DEVICE INFORMATION**

Figure 8 shows the ball locations for the 120-ball plastic ball grid array (PBGA) package and is used in conjunction with ball description to locate signal names and ball grid numbers.



Bottom View



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Figure 8. PBGA Bottom View

Table 13.	Terminal/Pin	Functions
-----------	--------------	-----------

NAME	BALL	SUPPLIES	TYPE	I/O	DESCRIPTION	PU/PD
ADCIN0	F2		Analog	I/O	General-purpose ADC input	NO
STAR.ADC/JTAG. TDI	H7	VDDIO/DGND	Digital	I	ADC conversion request/JTAG test data input	NO
SDA	C4	VDDIO/DGND	Digital	I/O	I <sup>2</sup> C bidirectional data signal	External PU
SCL	B3	VDDIO/DGND	Digital	I/O	I <sup>2</sup> C bidirectional clock signal	External PU
SRI2C_SDA	D4	VDDIO/DGND	Digital	I/O	HS I <sup>2</sup> C bidirectional data signal	External PU
SRI2C_SCL	A3	VDDIO/DGND	Digital	I/O	HS I <sup>2</sup> C bidirectional Clock signal	External PU

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		Table 13. Term	inal/Pin Function	ons (continue	d)	
PWRON	D5	VBAT/GND	Digital	I	Input detects a control command to start or stop the system.	NO
REGEN	G3		Digital	0	Enable signal for external LDO	PU
MSECURE	G8	VDDIO/DGND	Digital	I	Security and digital rights management	NO
BOOT0	E5	VBAT/GND	Digital	I	Power-up sequence selection	Programmable PD (default active)
BOOT1	F6	VBAT/GND	Digital	I	Power-up sequence selection	Programmable PD (default active)
NRESPWRON	E7	VDDIO/DGND	Digital	ο	Output control the NRESPWRON of the application processor	NO
NRESWARM	H8	VDDIO/DGND	Digital	I	Warm reset signal	PU
NSLEEP	K4	VDDIO/DGND	Digital	I	ACTIVE-SLEEP state transition control signal	NO
INT	A9	VDDIO/DGND	Digital	0	Output line interrupt	NO
SYSEN	В9	VDDIO/DGND	Digital	0	System enable output	NO
CLKEN	F10	VDDIO/DGND	Digital	0	Clock Enable	NO
CLK32KOUT	G6	VDDIO/DGND	Digital	0	32-kHz clock output	PD disabled in ACTIVE state
32KXOUT	G11	VRTC/REFGND	Analog	I	32-kHz crystal oscillator	NO
32KXIN	H11	VRTC/REFGND	Analog	I	32-kHz crystal oscillator	NO
HFCLKIN	C8	VDDIO/DGND	Analog	I	Sine wave or square wave input	NO
HFCLKOUT	К8	VDDIO/DGND	Digital	0	50% duty cycle square wave output	NO
VREF	G10	VCC5/REFGND	Analog	0	Bandgap voltage	NO
REFGND	K7	REFGND	Analog	I/O	Reference ground	NO
AGND	H10	AGND	Analog	I/O	Substrate ground	NO
DGND	B8	DGND	Power	I/O	Digital ground	NO
IO.1P8	A10		Power	I	Supply for I/O buffers (VDDIO)	NO
VBACKUP	G9	VACKUP/AGND	Power	I	Must be shorted to GND	NO
VDD1.IN	E9, E10, E11		Power	I	VDD1 DCDC input	NO
VDD1.GND	A11, B10, B11		Power	I/O	VDD1 DCDC power ground	NO
VDD1.L	C10, C11, D10		Power	0	VDD1 DCDC switched output	NO
VDD1.FDBK	D11		Analog	I	VDD1 feedback voltage (output)	PD
VDD2.IN	K10, L10		Power	I	VDD2 DCDC input	NO

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Table 13. Terminal/Pin Functions (continued)

		Table 13. Terminal/Pin	Functions (con	tinued)	
VDD2.GND	J10, J11	Pov	wer I/C	D VDD2 DCDC power ground	NO
VDD2.L	K11, L11	Pov	wer C	VDD2 DCDC switched output	NO
VDD2.FDBK	H9	Ana	alog I	VDD2 feedback voltage (output)	PD
VIO.IN	K2, L2	Pov	wer I	VIO DCDC input	NO
VIO.GND	J1, J2	Pov	wer I/C	O VIO DCDC power ground	NO
VIO.L	K1, L1	Pov	wer C	VIO DCDC switched output	NO
VIO.FDBK	H1	Ana	alog I	VIO feedback voltage (output)	PD
VAUX12S.IN	F1	Por	wer I	VAUX LDO input	NO
VAUX.OUT	G1	Por	wer C	VAUX regulator output	PD
VPLLA3R.IN	A6	Pov	wer I	VPLL//VRTC LDO input	NO
VPLL1.OUT	A8	Pov	wer C	VPLL LDO regulator output	PD
VRTC.OUT	В5	Por	wer C	VRTC internal LDO regulator output (internal use only)	PD
VINT.IN	A7	Pov	wer I	VINTDIG LDO input	NO
VINTANA1	D1	Por	wer C	VINTANA1 internal LDO regulator output (internal use only)	PD
VINTANA2	A2	Por	wer C	VINTANA2 internal LDO regulator output (internal use only)	PD
VDAC.IN	C1	Pov	wer I	VDAC/VINTANA1/ VINTAN2 LDO input	NO
VDAC.OUT	E1	Pov	wer C	VDAC LDO regulator output	PD
VINTDIG.OUT	В7	Por	wer C	VINTDIG internal LDO regulator output (internal use only)	PD
VMMC1.OUT	A1	Pov	wer C	VMMC LDO regulator output	PD
VBAT.USB	K6	Por	wer I	VINTUSBiP5,VIN TUSB1P8,VUSB. 3P1 input regulator	NO
VUSB.3P1	L6	Pov	wer C	VUSB.3P1 LDO regulator output	PD
VUSB1P8.OUT	J6	Po	wer C	VUSB1P8 LDO regulator output (internal use only)	PD
VUSB1P5.OUT	J5	Por	wer C	VUSB1P5 LDO regulator output (internal use only)	PD
TESTV1	H2	Ana	alog IC	O Analog test pin 1	NO
TESTV2	C9	Ana	alog IC	O Analog test pin 2	NO

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		Table 13. Term	inal/Pin Functio	ons (continue	ed)	
TEST	D3	VDDIO/DGND	Digital	IO	Digital test pin	PD
AVSS1	F3	AGND	Power	I/O	Analog ground	NO
AVSS2	H6	AGND	Power	I/O	Analog ground	NO
AVSS3	F9	AGND	Power	I/O	Analog ground	NO
AVSS4	A4	AGND	Power	I/O	Analog ground	NO
VBUS	K5		Power		VBUS power rail	NO
DP	L7		Analog	I/O	USB differential data line	NO
DM	L8		Analog	I/O	USB differential data line	NO
ID	J7	VDDIO/DGND	Digital	I/O	USB ID	NO
UCLK	D6	VDDIO/DGND	Digital	I/O	HS USB Clock	NO
STP	E6	VDDIO/DGND	Digital	I/O	HS USB Stop	NO
DIR	A5	VDDIO/DGND	Digital	I/O	HS USB Direction	NO
NXT	C5	VDDIO/DGND	Digital	I/O	HS USB Next	NO
DATA0	B6	VDDIO/DGND	Digital	I/O	HS USB Data0	NO
DATA1	C6	VDDIO/DGND	Digital	I/O	HS USB Data1	NO
DATA2	C7	VDDIO/DGND	Digital	I/O	HS USB Data2	NO
DATA3	D7	VDDIO/DGND	Digital	I/O	HS USB Data3	NO
DATA4	F8	VDDIO/DGND	Digital	I/O	HS USB Data4	NO
DATA5	F11	VDDIO/DGND	Digital	I/O	HS USB Data5	NO
DATA6	E8	VDDIO/DGND	Digital	I/O	HS USB Data6	NO
DATA7	D9	VDDIO/DGND	Digital	I/O	HS USB Data7	NO
CP_IN	L4		Power	I/O	Charge pump input voltage	NO
CP_GND	J3		Power Gnd	I/O	Charge pump ground	NO
CP_CAPP	L5		Analog	I/O	Charge pump flying capacitor P	NO
CP_CAPM	L3		Analog	I/O	Charge pump flying capacitor M	NO
KPD.C0	B4	VDDIO/DGND	Open Drain	0	Keypad column 0	PU
KPD.C1	D2	VDDIO/DGND	Open Drain	0	Keypad column 1	PU
KPD.C2	E2	VDDIO/DGND	Open Drain	0	Keypad column 2	PU
KPD.C3	B2	VDDIO/DGND	Open Drain	0	Keypad column 3	PU
KPD.C4	C2	VDDIO/DGND	Open Drain	0	Keypad column 4	PU
KPD.C5	E4	VDDIO/DGND	Open Drain	0	Keypad column 5	PU
KPD.C6	E3	VDDIO/DGND	Open Drain	0	Keypad column 6	PU
KPD.C7	F4	VDDIO/DGND	Open Drain	0	Keypad column 7	PU
KPD.R0	H5	VDDIO/DGND	Digital	I	Keypad row 0	PU
KPD.R1	G4	VDDIO/DGND	Digital	I	Keypad row 1	PU
KPD.R2	H4	VDDIO/DGND	Digital	I	Keypad row 2	PU
KPD.R3	G5	VDDIO/DGND	Digital	I	Keypad row 3	PU
KPD.R4	J4	VDDIO/DGND	Digital	I	Keypad row 4	PU
KPD.R5	J8	VDDIO/DGND	Digital	I	Keypad row 5	PU
KPD.R6	G7	VDDIO/DGND	Digital	I	Keypad row 6	PU
KPD.R7	F5	VDDIO/DGND	Digital	I	Keypad row 7	PU
VBAT	КЗ		Power	I/O	Battery input voltage	NO
CLKREQ	D8	VDDIO/DGND	Digital	1		PD

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Table 13. Terminal/Pin Functions (continued)									
TEST.RESET	J9	VBAT/GND	Digital	I	Reset the device (except the state-machine)	PD			
VPROG	H3		Analog	I	Using to program EEPROM	NO			
JTAG.TCK	F7	VDDIO/DGND	Digital	I	JTAG clock input	NO			
JTAG.TDO/GPIO	L9	VDDIO/DGND	Digital	I/O	JTAG test output or GPIO0/card detection 1	PD			
JTAG.TMS/GPIO	K9	VDDIO/DGND	Digital	I/O	JTAG test mode state or GPIO1/card detection 2	PD			
TEST/GPIO	G2	VDDIO/DGND	Digital	I	Selection between JTAG mode and application mode	Programmable PD			
VMMC.IN	B1		Power	I	VMMC input LDO	NO			

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	1	2	3	4	5	6	7	8	9	10	11	
A	VMMC1.OUT	VINTANA2. OUT	VMODE2/ I2C.SR.SCL	AVSS4	DIR/GPIO.10	VPLLA3R.IN	VINT.IN	VPLL1.OUT	INT1	IO.1P8	VDD1.GND	A
в	VMMC1.IN	KPD.C3	I2C.CNTL. SCL	KPD.C0	VRTC.OUT	DATA0/ UART4.TXD	INTDIG.OUT	DGND	SYSEN	VDD1.GND	VDD1.GND	в
с	VDAC.IN	KPD.C4	#N/A	I2.CNTL.SDA	NXT/GPIO.11	DATA1/ UART4.RXD	DATA2/ UART4.RTSI	HFCLKIN	TESTV2	VDD1.L	VDD1.L	с
D	VINTANA1. OUT	KPD.C1	TEST	PWROK2/ 12C.SR.SDA	PWRON	UCLK	DATA3/ UART4. CTSO/ GPIO.12	CLKREQ	DATA7/ GPIO.5	VDD1.L	VDD1.OUT	D
E	VDAC.OUT	KPD.C2	KPD.C6	KPD.C5	BOOT0	STP/GPIO.9	NRESPWRON	DATA6/ GPIO.4	VDD1.IN	VDD1.IN	VDD1.IN	E
F	VAUX12S.IN	ADCIN0	AVSS1	KPD.C7	KPD.R7	BOOT1	JTAG.TCK/ BERCLK	DATA4/ GPIO.14	AVSS3	CLKEN	DATA5/ GPIO.3	F
G	VAUX2.OUT	GPIO.2/ TEST1	REGEN	KPD.R1	KPD.R3	32KCLKOUT	KPD.R6	MSECURE	BKBAT	VREF	32KXOUT	G
н	VIO.OUT	TESTV1	VPROG	KPD.R2	KPD.R0	AVSS2	STARTADC	NRESWARM	VDD2.OUT	AGND	32KXIN	н
J	VIO.GND	VIO.GND	CP.GND	KPD.R4	VINTUSB1P5. OUT	VINTUSB1P8. OUT	ID	KPD.R5	TEST.RESET	VDD2.GND	VDD2.GND	J
к	VIO.L	VIO.IN	VBAT	NSLEEP1	VBUS	VBAT.USB	GND_AGND	HFCLKOUT	GPIO.1/CD2/ JTAG.TMS	VDD2.IN	VDD2.L	к
L	VIO.L	VIO.IN	CP.CAPM	CP.IN	CP.CAPP	VUSB.3P1	DP/UART3. RXD	DN/UART3. TXD	GPIO.0/CD1/ JTAG.TD0	VDD2.IN	VDD2.L	L
	1	2	3	4	5	6	7	8	9	10	11	

Figure 9. Ball Placement

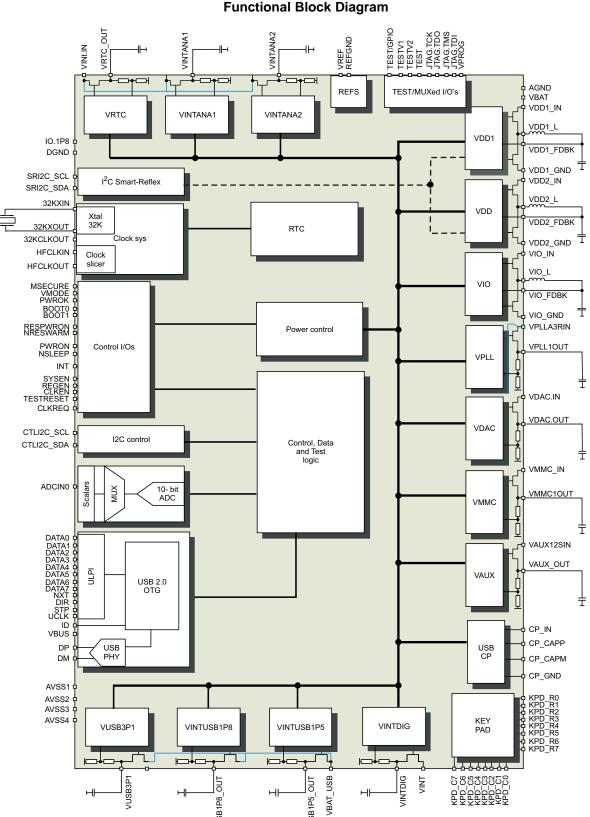
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VUSB3P1

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## DETAILED DESCRIPTION

## **CLOCK SYSTEM**

Figure 10 shows the TPS65921 clock overview.

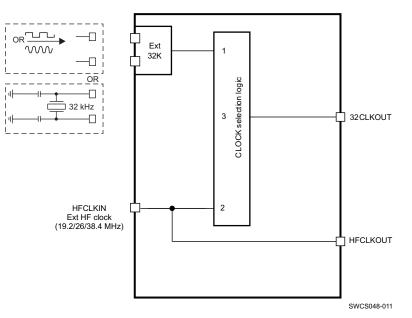


Figure 10. TPS65921 Clock Overview

The TPS65921 device can provide:

- 32KCLKOUT digital output clock generated starting from:
  - The 32-kHz RC oscillator ((3) in the block scheme)
  - The 32-kHz crystal oscillator ((1) in the block scheme). Optionally, an external 32-kHz input clock can be provided
  - HFCLKIN: an external high-frequency clock (19.2, 26, or 38.4 MHz) ((2) in the block scheme), through a
    dedicated internal divider, included in the CLOCK selection logic
- HFCLKOUT digital output clock with the same frequency as HFCLKIN input clock and through the clock slicer

The TPS65921 device includes a 32-kHz RC oscillator which is used as reference clock during the device startup and device is running with RC oscillator if 32-kHz crystal oscillator is tied to ground.

When the 32-kHz crystal oscillator is on provides a 32kok signal (equal to 1 meaning the crystal oscillator is on and the clock is stable), which is used to disable the RC oscillator.

If HFCLKIN is present, 32KCLKOUT switches from 32-kHz crystal or 32-kHz RC to HFCLKIN divided by the internal divider.

## 32-kHz OSCILLATOR

Figure 11 shows the 32-kHz oscillator block diagram with a 32.768-kHz square or sine signal in master and slave modes. Figure 12 shows an external clock source when the oscillator is configured in bypass mode. Thus, there are three configurations:

- A square- or sine-wave input can be applied to the 32KXIN pin with amplitude of 1.85 or 1.8 V. The 32KXOUT pin can be left floating. This configuration, shown in Figure 11, is used if no charge is applied on the 32KXOUT pin.
- The oscillator is in bypass mode and a square-wave input can be applied to the 32KXIN pin with amplitude of 1.8 V. The 32KXOUT pin can be left floating. This configuration, shown in Figure 12, is used if the oscillator is in bypass mode.

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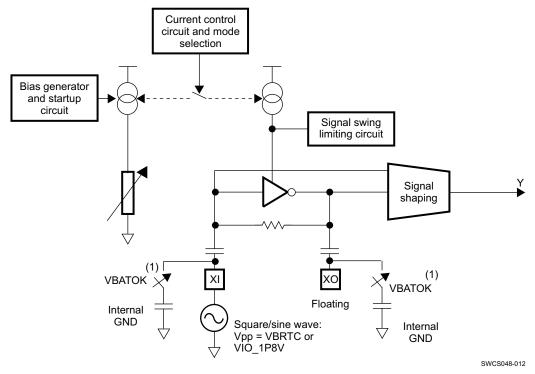
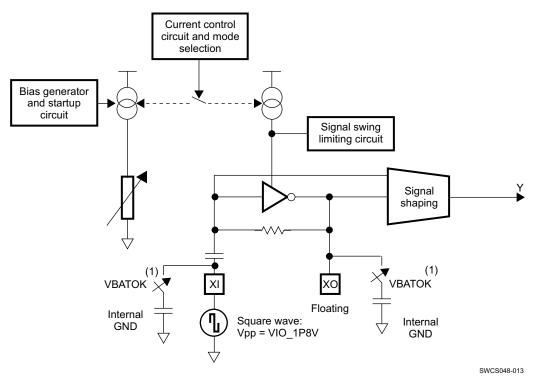


Figure 11. 32-kHz Oscillator Block Diagram Without Crystal, Option 1.

(1) Switches close by default and open only if register access enables the very-low-power mode when VBAT < 2.7 V.



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Switches close by default and open only if register access enables the very-low-power mode when VBAT < 2.7 V.</li>
 Figure 13 shows the block diagram for the 32.768-kHz clock output.

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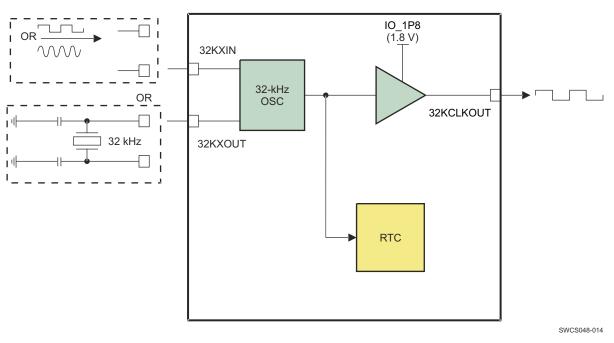


Figure 13. 32.768-kHz Clock Output Block Diagram

The TPS65921 device has an internal 32.768-kHz oscillator connected to an external 32.768-kHz crystal through the 32KXIN/32KXOUT balls or an external digital 32.768-kHz clock through the 32KXIN input (see Figure 13). The TPS65921 device also generates a 32.768-kHz digital clock through the 32KCLKOUT pin and can broadcast it externally to the application processor or any other devices. The 32KCLKOUT clock is broadcast by default in the TPS65921 active mode but can be disabled if it is not used.

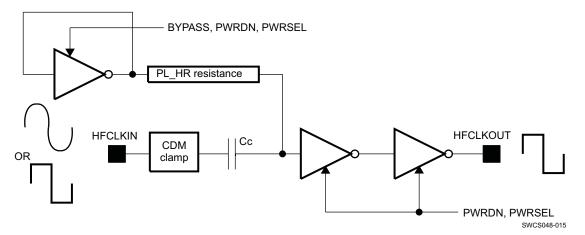
The 32.768-kHz clock (or signal) is also used to clock the RTC (real-time clock) embedded in the TPS65921. The RTC is not enabled by default. It is up to the host processor to set the correct date and time and to enable the RTC functionality.

The 32KCLKOUT output buffer can drive several devices (up to 40-pF load). At start-up, the 32.768-kHz output clock (32KCLKOUT) must be stabilized (frequency/duty cycle) prior to the signal output. Depending on the start-up condition, this may delay the start-up sequence.

# **CLOCK SLICER**

Figure 14 shows the clock slicer block diagram.

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The clock slicer is disabled by default and enabled when the CLKEN pad is high. The slicer transforms the HFCLKIN clock input signal into a squared clock signal used internally by the TPS65921 device and also outputs it for external use. The HFCLKIN input signal can be:

- A sinusoid with peak-to-peak amplitude varying from 0.3 to 1.45 V
- A square clock signal of amplitude 1.85 V maximum. In the case of a square clock signal, the slicer is configured in bypass or power-down mode. If a square-wave input clock is provided, it is recommended to switch the block to bypass mode when possible to avoid loading the clock.

The HFCLKIN input clock frequency must be 19.2, 26, or 38.4 MHz.

Four different modes are programmable by register. By default, the slicer is in high-performance application mode:

- Bypass mode (BP): In BP mode, which overrides all the other modes, the input signal is directly connected to the output through some buffers. The input is a rail-to-rail square wave.
- Power-down mode (PD): During PD mode, the cell does not consume any current if bypass mode is not active.
- Low-power application mode (LP): In LP mode, the input sine wave is converted to a CMOS signal (square wave) with low power consumption.
- High-performance application mode (HP): In HP mode, the input sine wave is converted to a CMOS signal (square wave). It has lower duty cycle degradation and lower input-to-output delay in comparison to the low-power mode, but it consumes more current. The drive of the squaring inverter is increased by connecting additional inverters in parallel. Details can be found in the clock slicer electrical characteristics table.

Figure 15 shows the HFCLKIN clock distribution.

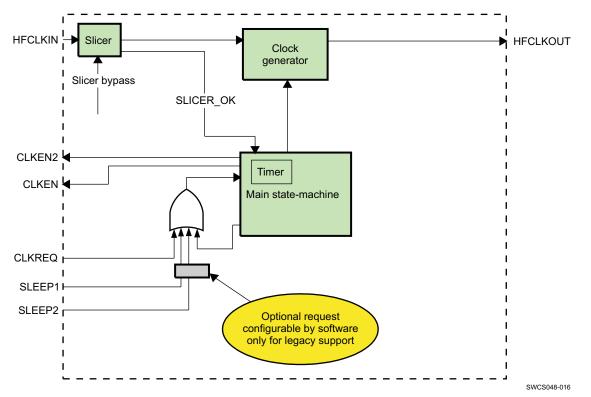


Figure 15. HFCLKIN Clock Distribution

When a device needs a clock signal other than 32.768 kHz, it makes a clock request and activates the CLKREQ pin. As a result, the TPS65921 device immediately sets CLKEN to 1 to warn the clock provider in the system

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about the clock request and starts a timer (maximum of 10 ms and uses the 32.768-kHz clock). Once the timer expires, the TPS65921 device opens a gated clock, the timer automatically reloads the defined value and a high-frequency output clock signal is available through the HFCLKOUT pin. The output drive of HFCLKOUT is programmable (low drive (MISC\_CFG[CLK\_HF\_DRV] = 0) maximum load 20 pF, high drive (MISC\_CFG[CLK\_HF\_DRV] = 1) maximum load 30 pF), by default it is programmed to support Low Drive.

With a register setting, the mirroring of CLKEN can be enabled on CLKEN2. When this mirroring feature is not enabled, the signal CLKEN2 can be used as a general-purpose output controlled through I<sup>2</sup>C accesses.

CLKREQ, when enabled, has a weak pulldown resistor to support the wired-OR clock request.

Figure 16 shows an example of the wired-OR clock request.

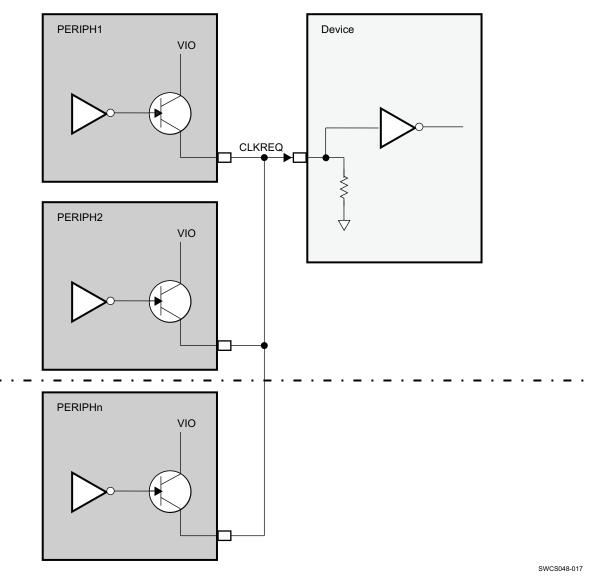


Figure 16. Example of Wired-OR Clock Request

The timer default value must be the worst case (10 ms) for the clock providers. For legacy or workaround support, the signals NSLEEP1 and NSLEEP2 can also be used as a clock request even if it is not their primary goal. By default, this feature is disabled and must be enabled individually by setting the register bits associated with each signal.

When the external clock signal is present on the HFCLKIN ball, it is possible to use this clock instead of the internal RC oscillator and then synchronize the system on the same clock. The RC oscillator can then go to idle.

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### POWER PATH

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#### **Step-Down Converters**

Depending on the system requirements, and also to optimize mean consumption, three operating modes are allowed for each step-down converter:

- Off/power-down mode: Output voltage is not maintained, and power consumption is null
- Active: DCDC can deliver its nominal output voltage with a full load current capability. The clock selected for the 3.2-MHz oscillator is the local oscillator or an external high-frequency clock.
- Sleep: The nominal output voltage is maintained with low power consumption, but also with a low load-current capability. The clock selected for the 3.2-MHz oscillator is the local oscillator.

The SMPS operates with three modulation schemes:

- Light pulse frequency modulation (PFM)
- Pulse skipping mode (PSM)
- Continuous pulse-width modulation (PWM)

Each DCDC, all of which have the same electrical characteristics, has an integrated RC oscillator. The use of these RC oscillators is configurable through register bits, and by default the RC oscillator of VDD1 is used for all DCDC.

#### LDO

The VPLL programmable LDO regulator is high-PSRR, low-noise, linear regulator used for the host processor PLL supply.

The VDAC programmable LDO regulator is a high-PSRR, low-noise, linear regulator that powers the host processor dual-video DAC. It is controllable with registers through I<sup>2</sup>C and can be powered down.

The VMMC LDO regulator is a programmable linear voltage converter that powers the MMC slot. It includes a discharge resistor and over-current protection (short circuit). This LDO regulator can also be turned off automatically when the MMC card extraction is detected (through one dedicated GPIO). The VMMC LDO can be powered through an independent supply other than the battery; for example, a charge pump. In this case, the input from the VMMC LDO can possibly be higher than the battery voltage.

The VAUX general-purpose LDO regulator powers the auxiliary devices.

The VRRTC voltage regulator is a programmable, LDO, linear voltage regulator supplying (1.5 V) the embedded RTC (32.768-kHz oscillator) and dedicated I/Os of the digital host counterpart. The VRRTC regulator is also the supply voltage of the power-management digital state-machine. The VRRTC regulator is supplied from the UPR line, switched on by the main or backup battery, depending on the system state. The VRRTC output is present as long as a valid energy source is present. The VRRTC line is supplied by an LDO when VBAT > 2.7, and a clamp circuit when in backup mode.

The VINTDIG LDO regulator supplies the TPS65921 digital blocks.

To supply the TPS65921 analog blocks, there are two LDOs: VINTANA1 (1.5 V) and VINTANA2 (2.75 V/2.5 V). The 2.5-V setting is selected when the battery voltage falls below 3.0 V.

The VUSB3V1 internal LDO regulator powers the USB PHY, charger detection, and OTG of the USB subchip inside the TPS65921 device.

It can take its power from two possible sources:

- VBAT.USB (only for high battery voltages)
- VBUS (only in low-power mode, shared with CP.OUT)

See Charge-pump section for more details.

The USB standard requires data lines to be biased with pullups biased from a > 3.0 V supply, USB PHY cannot directly operate from VBAT.USB for battery voltages lower than 3.3 V.

In such case, VBUS should be supplied by a boosted voltage to ensure enough overhead for USB LDO operation. An internal charge pump (whose output is connected to VBUS/CP.OUT) can be used for this purpose.

To select between these three power sources, a power mux is connected to the VUSB3V1 LDO supply.



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The VUSB1V8 and VUSB1V5 internal LDO regulators power the USB subchip inside the TPS65921 device.

The short-circuit current for the LDOs and DCDCs in the TPS65921 device is approximately twice the maximum load current. In certain cases when the output of the block is shorted to ground, the power dissipation can exceed the 1.2 W requirement if no action is taken. A short-circuit protection scheme is included in the TPS65921 device to ensure that if the output of an LDO or DCDC is short-circuited, then the power dissipation does not exceed the 1.2 W level.

The three USB LDOs VUSB3V1, VUSB1V8, and VUSB1V5 are included in this short circuit protection scheme which monitors the LDO output voltage at a frequency of 1 Hz, and generates an interrupt when a short circuit is detected.

The scheme compares the LDO output voltage to a reference voltage and detects a short circuit if the LDO voltage drops below this reference value (0.5 V or 0.75 V programmable). In the case of the VUSB3V1 and VUSB1V8 LDOs, the reference is compared with a divided down voltage (1.5 V typical).

If a short circuit is detected on VUSB3V1, then the power subchip FSM switches this LDO to sleep-mode.

If a short circuit is detected on VUSB1V8 or VUSB1V5, then the power subchip FSM switches the relevant LDO off.

#### **Power Reference**

The bandgap voltage reference is filtered (RC filter), using an external capacitor connected across the VREF output and an analog ground (REFGND). The VREF voltage is scaled, distributed, and buffered inside the device. The bandgap is started in fast mode (not filtered) and is set automatically by the power state-machine in slow mode (filtered, less noisy) after switch on.

#### **Power Control**

If the backup battery is rechargeable, then it can be recharged from the main battery. A programmable voltage regulator powered by the main battery allows recharging of the backup battery. The backup battery charging must be enabled using a control bit register. Charging starts when the following two conditions are met:

- Main battery voltage > backup battery voltage
- Main battery voltage > VMBCH (see electrical specification for values)

Charging continues as long as these conditions are met.

The comparators of the BBS give the two thresholds of the backup battery charging start up. The programmed voltage for the charger gives the end-of-charge threshold. The programmed current for the charger gives the charging current.

#### **Power Use Cases**

The TPS65921 device has two modes:

- Master: The TPS65921 device decides to power up or down the system and control the other power ICs in the system with the SYSEN output.
- Slave: The TPS65921 device is controlled by another power IC with a digital signal on the PWRON input. There is no battery management in slave mode.

The modes corresponding to BOOT0-BOOT1 combination value are:

NAME	DESCRIPTION	BOOT0	BOOT1
MC021 <sup>(1)</sup>	Master_C021_Generic 10	1	0
SC021	Slave_C021_Generic 11	1	1

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(1) Boot mode for OMAP3430 is c021 Master boot mode.

Process modes define:

- The boot voltage for the host core
- The boot sequence associated with the process
- The DVFS protocol associated with the process





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MODE	C021.M
Boot core voltage	1.2 V
Power sequence	VIO followed by VPLL1, VDD2, VDD1
DVFS protocol	SmartReflex interface (I <sup>2</sup> C high speed)

Regulator states depending on use cases:

REGULATOR	MODE: C021 (MASTER/SLAVE) and C027 (MASTER)					
	BACKUP	WAIT ON	SLEEP NO LOAD	ACTIVE NO LOAD		
VAUX2	OFF	OFF	OFF	OFF		
VMMC1	OFF	OFF	OFF	OFF		
VPLL1	OFF	OFF	SLEEP	ON		
VDAC	OFF	OFF	OFF	OFF		
VINTANA1	OFF	OFF	SLEEP	ON		
VINTANA2	OFF	OFF	SLEEP	ON		
VINTDIG	OFF	OFF	SLEEP	ON		
VIO	OFF	OFF	SLEEP	ON		
VDD1	OFF	OFF	SLEEP	ON		
VDD2	OFF	OFF	SLEEP	ON		
VUSB1V5	OFF	OFF	OFF	OFF		
VUSB1V8	OFF	OFF	OFF	OFF		
VUSB3V1	OFF	OFF	SLEEP	ON		

#### **Power Timing**

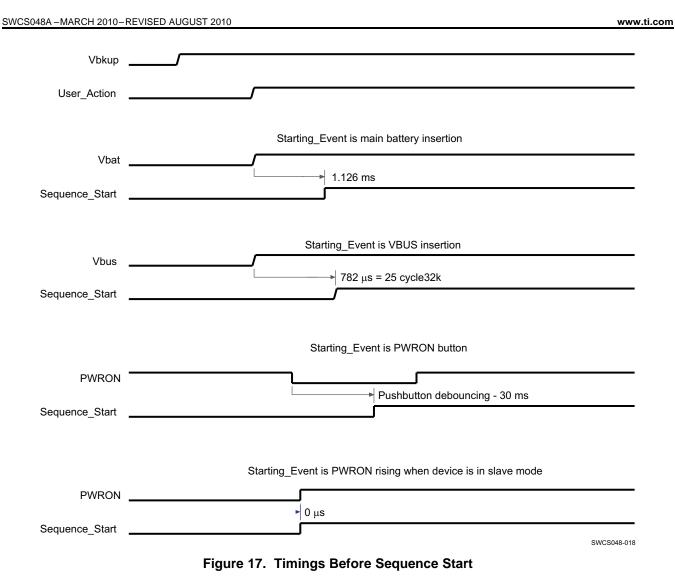
Sequence start is a symbolic internal signal to ease the description of the power sequences and occurs according to the different events detailed in Figure 17.

Sequence start timing depends on the TPS65921 starting event. If the starting event is:

- Main battery insertion, event time is 1.126 ms (time to set up internal LDO and relax internal reset)
- VBUS insertion, event time is 25 cycles of 32k

# TPS65921





# Switch On In MASTER\_C021\_GENERIC Mode

Figure 18 describes the timing and control that must occur in Master\_C021\_Generic mode. Sequence\_Start is a symbolic internal signal to ease the description of the power sequences and occurs according to the different events detailed in Figure 17.

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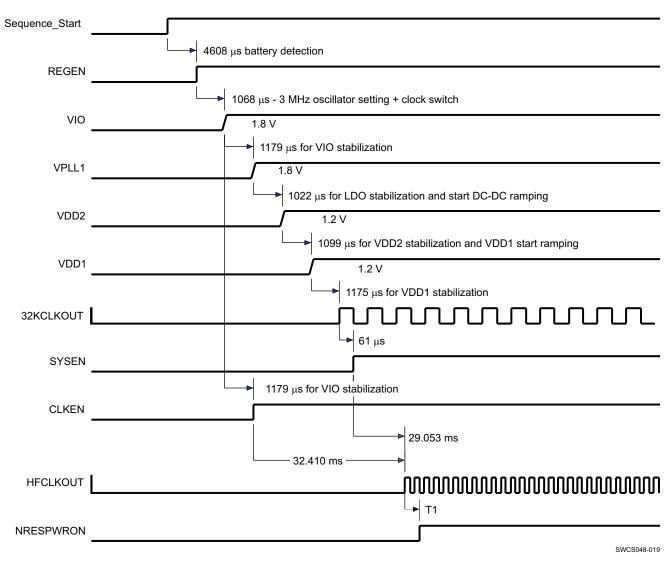


Figure 18. Timings—Switch On in Master\_C021\_Generic Mode

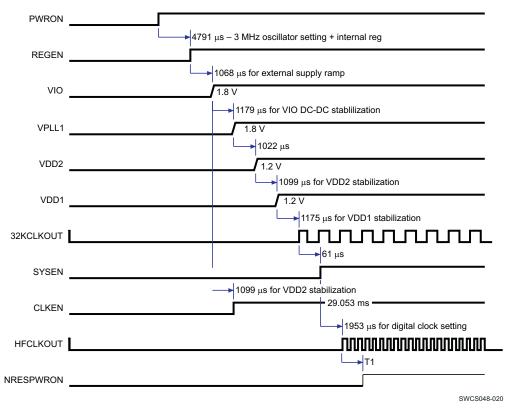
PARAMETER		MIN	MAX	UNIT
Τ1	With external clock from quartz	10	11	32k clock cycles



# Switch On In SLAVE C021 GENERIC Mode

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Figure 19 describes the timing and control that must occur in Slave\_C021\_Generic mode. Sequence\_Start is a symbolic internal signal to ease the description of the power sequences and occurs according to the different events detailed in Figure 17.



# Figure 19. Timings—Switch On in Slave\_C021\_Generic Model

PARAMETER		MIN	МАХ	UNIT
T1	With external clock from quartz	10	11	32k clock cycles

#### Switch-Off Sequence

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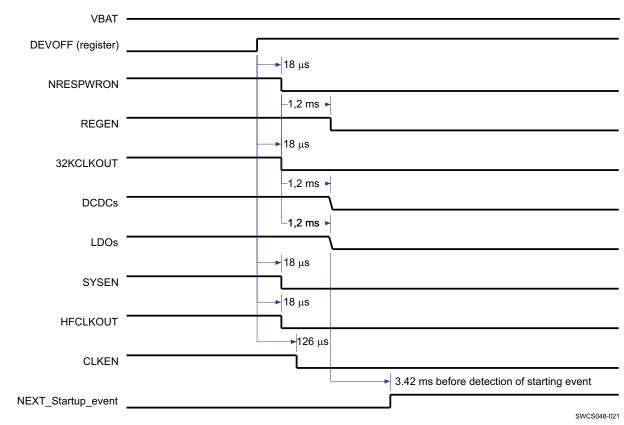
This section describes the signal behavior required to switch off the system.

#### Switch-Off Sequence In Master Modes

Figure 20 describes the timing and control that occur during the switch-off sequence in master modes.



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NOTE: All of the above timings are the typical values with the default setup (depending on the resynchronization between power domains, state machinery priority, etc.).

#### Figure 20. Switch-Off Sequence in Master Modes

In case the value of the HF clock is different from 19.2 MHz (with HFCLK\_FREQ bit field values set accordingly inside the CFG\_BOOT register), then the delay between DEVOFF and NRESPWRON/CLK32KOUT/SYSEN/HFCLKOUT is divided by 2 (meaning around 9  $\mu$ s). This is due to the internal frequency used by POWER STM switching from 3 MHz to 1.5 MHz in case the value of the HF clock is 19.2 MHz.

The DEVOFF event is the PWRON falling edge in slave mode and the DEVOFF internal register write in master mode.

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#### Switch-Off Sequence in Slave Mode

Figure 21 describes the timing and control that occur during the switch off-sequence in slave mode.

VBAT PWRON	
T WILCON	▶18 μs
NRESPWRON	
REGEN	
	▶ 18 μs
32KCLKOUT	
	-1,2 ms▶
DCDCs	
	_1,2 ms▶
LDOs	
	▶ 18 μs
SYSEN	
	—→ 18 μs
HFCLKOUT	
	3.42 ms before detection of starting event
NEXT_Startup_event	6 ms (see comment in notes
	about reducing this interval)
VIO	
	SWCS048-0

NOTE:All of the above timings are the typical values with the default setup (depending on the resynchronization between<br/>powerpowerdomains,statemachinerypriority,etc.).If necessary, the 6-ms period to maintain VIO and 32KXIN after PWRON goes low can be reduced to 150 μs. For<br/>more information,see comments in the Power Up section of the TRM.

# Figure 21. Switch-Off Sequence in Slave Mode

In case the value of the HF clock is different from 19.2 MHz (with HFCLK\_FREQ bit field values set accordingly inside the CFG\_BOOT register), then the delay between DEVOFF and NRESPWRON/CLK32KOUT/SYSEN/HFCLKOUT is divided by 2 (meaning around 9  $\mu$ s). This is due to the internal frequency used by POWER STM switching from 3 MHz into 1.5 MHz in case the value of the HF clock is 19.2 MHz.

# Charge Pump

The charge pump generates a 5.0-V (nominal) power supply voltage from battery to the VBUS CP.OUT/VUSB.IN pin. The input voltage range is 2.7 to 4.5 V for the battery voltage. The charge pump operating frequency is 1 MHz.

The charge pump tolerates 6 V on VBUS/CP.OUT when it is in power down mode. The charge pump integrates a short-circuit current limitation at 450 mA.

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Figure 22 shows the charge pump.

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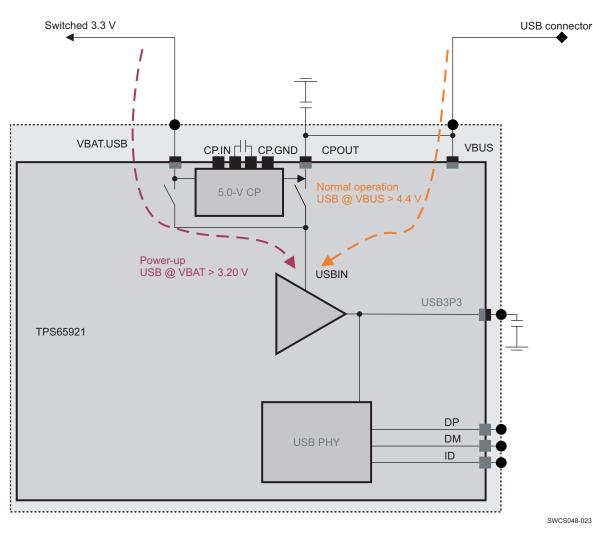


Figure 22. General Overview of the Charge Pump and Its Interfaces.

It can be used to supply USB 3.1 V LDO when battery voltage is lower than this LDO VBATmin voltage (see electrical characteristics).

By adding an external series switch under software control, charge-pump output voltage can be used as an on-the-go (OTG) supply to power OTG-B devices.

#### **USB Transceiver**

The TPS65921 device includes a USB OTG transceiver that support USB 480 Mbps HS, 12 Mbps FS, and USB 1.5 Mbps LS through a 4-pin UTMI+ ULPI.

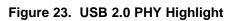
It also includes a module covering Battery Charging Specification v1.0. Figure 23 shows the USB 2.0 PHY highlight block diagram.

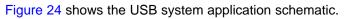
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USB OTG device Free headset UART control Audio accessory OMAP Device (LINK) **USB PHY** ULPI PC Phone connector (USB or MCPC) ADC inputs Charger (optional) SWCS048-024





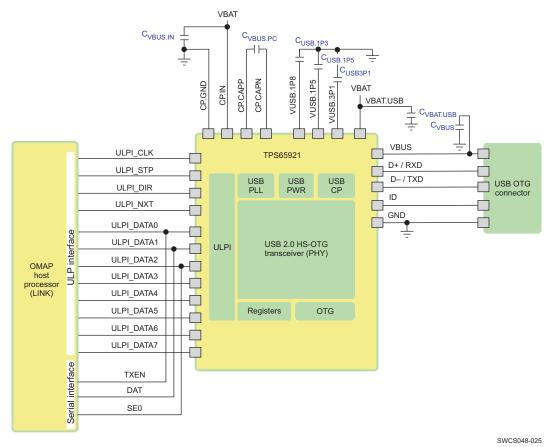


Figure 24. USB System Application Schematic

# PHY

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The PHY is the physical signaling layer of the USB 2.0. It contains all the drivers and receivers required for physical data and protocol signaling on the DP and DM lines.

The PHY interfaces to the USB controller through a standard digital interface called the universal transceiver macro cell interface (UTMI).

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The transmitters and receivers inside the PHY are classified into two main classes:

- The FS and LS transceivers. These are the legacy USB1.x transceivers.
- The HS transceivers



To bias the transistors and run the logic, the PHY also contains reference generation circuitry consisting of:

- A DPLL, which does a frequency multiplication to achieve the 480-MHz low-jitter lock necessary for USB, and also the clock required for the switched capacitor resistance block.
- A switched capacitor resistance block used to replicate an external resistor on chip.

Built-in pullup and pulldown resistors are used as part of the protocol signaling.

Apart from this, the PHY also contains circuitry that protects it from an accidental 5 V short on the DP and DM lines.

#### LS/FS Single-Ended Receivers

In addition to the differential receiver, there is a single-ended receiver (SE–, SE+) for each of the two data lines D+/-. The main purpose of the single-ended receivers is to qualify the D+ and D– signals in the FS/LS modes of operation.

#### LS/FS Differential Receiver

A differential input receiver (RX) retrieves the LS/FS differential data signaling. The differential voltage on the line is converted into digital data by a differential comparator on DP/DM. This data is then sent to a clock and data recovery circuit, which recovers the clock from the data. In an additional serial mode, the differential data is directly output on the RXRCV pin.

#### LS/FS Transmitter

The USB transceiver (TX) uses a differential output driver to drive the USB data signal D+/– onto the USB cable. The outputs of the driver support 3-state operation to achieve bidirectional half-duplex transactions.

#### **HS Differential Receiver**

The HS receiver consists of the following blocks:

- A differential input comparator to receive the serial data
- A squelch detector to qualify the received data
- An oversampler-based clock data recovery scheme followed by a NRZI decoder, bit unstuffing, and serial-to-parallel converter to generate the UTMI DATAOUT

#### HS Differential Transmitter

The HS transmitter is always operated on the UTMI parallel interface. The parallel data on the interface is serialized, bit-stuffed, NRZI-encoded, and transmitted as a DC output current on DP or DM depending on the data. Each line has an effective  $22.5-\Omega$  load to ground, which generates the voltage levels for signaling.

A disconnect detector is also part of the HS transmitter. A disconnect on the far end of the cable causes the impedance seen by the transmitter to double, thereby doubling the differential amplitude seen on the DP and DM lines.

#### UART Transceiver

In this mode, the ULPI data bus is redefined as a 2-pin UART interface, which exchanges data through a direct access to the FS/LS analog transmitter and receiver.

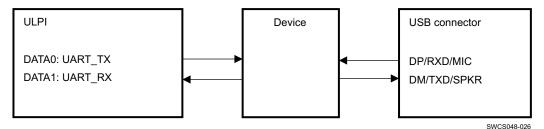
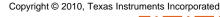


Figure 25. USB UART Data Flow

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The OTG block integrates three main functions:

- The USB plug detection function on VBUS and ID
- The ID resistor detection
- The VBUS level detection

# CHARGER DETECTION

To support Battery Charging Specification v1.0 [BCS v1.1], a charger detection module is included in the TPS65921 USB module.

The detection mechanism aims distinguishing several types of power sources that can be connected on VBUS line:

- Dedicated charger port
- Standard host port
- · Charging host port

The hardware includes:

- A dedicated voltage referenced pullup on DP line
- A dedicated current controlled pulldown on DM line
- A detection comparator on DM line
- A control/detection state-machine including timers

Additional circuitry is added on DP/DM respectively for data line symmetry (required for HS operation) and for possible future extension

ID pin status detection (as defined per OTG v1.3 standard) and DP/DM single-ended receivers (as defined per USB v2.0 standard) are also used to determine the type of device plugged on the USB connector.

For details on the detection mechanism, refer to [BCS v1.1] (1).

The charging detection feature has two modes (description of each mode follows):

- 1. Software CTL mode: Software has direct control of current source and USB charger detection comparator on DP/DM (enabled when USB\_SW\_CTRL\_EN=1) using USB\_CHRG\_CTRL registers bits.
- 2. Software FSM mode: Software can start and stop USB charger detection state-machine.

For both modes, DPPULLDOWN and DMPULLDOWN bits in OTG\_CTRL register are 1 by default. This can cause errors in charger detection. Therefore, both bits must be cleared to 0 before software begins charger detection sequence.

#### 1- Software CTL Mode (Manual detection):

When in this mode the charger detection circuitry is fully under control of software. Refer to POWER\_CONTROL register bits as to how to control the detection circuitry. Conditions:

- The TPS65921 device is powered and is in active mode.
- USB\_SW\_CHRG\_CTRL\_EN = 1, register bit set by the software
- USB\_CHG\_DET\_EN\_SW = 1, register bit set by the software

Control the USB\_SW\_CHRF\_CTRL register to achieve charger detection.

# 2- Software FSM Mode (Automatic detection):

The TPS65921 also supports automated battery charger detection through the USB battery charger detection FSM in Figure 26 while the chip is in active mode. This mode is set by software using the SW\_USB\_DET bit. When in this mode, the automated charger detection finite state-machine (FSM) is enabled. Refer to the state-machine for details. Conditions:

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- The TPS65921 device is powered and is in active mode.
- USB\_HW\_CHRG\_DET\_EN = 1

See the Register Map for more details.



The TPS65921 device also supports automated data contact detection in the FSM through the DATA\_CONTACT\_DET\_EN bit which should be set at the same time as SW\_USB\_DET above, before setting SW\_CONTROL bit. This enables a block of the FSM, which performs data contact detect for a maximum of DCD\_TIMEOUT before automatically skipping to charger detection.

See Figure 26,USB Battery Charger FSM, for details of how context is stored if SW\_CONTROL bit is set while in software FSM mode.

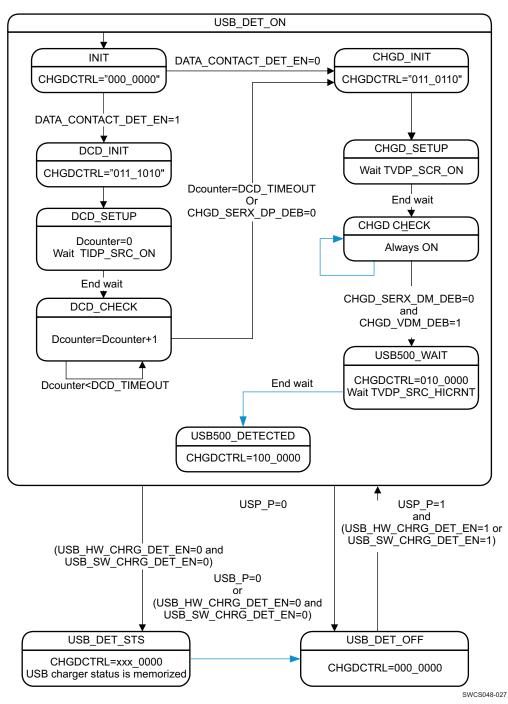


Figure 26. USB Battery Charger Detection FSM

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USB charger detection status bit definition:

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- USBVBUS\_PRES: Detect presence of valid VBUS. Comparator output is debounced for DEBVBUS\_TIME (minimum 10 ms) on CKCHG and generates a USB\_P signal. USB\_P is computed only if a battery presence is detected.
- USBCHRG\_PRES: Detect presence of USB charger on DP/DM. The feature is enabled through the USB\_DET\_EN signal, then USBPHY performs checks on DP/DM and return status USB\_DET\_RESULT:
  - 1 : USB 500-mA charger is detected.
  - 0: USB 100-mA charger is detected.
- USB\_DET\_STATUS: 500-mA/100-mA USB charger detect presence comparator output is debounced during DEBUSBCHG\_TIME (minimum 20 ms) on CKCHG, debounced signal is USB\_DET\_RESULT (set to 1 in case of 500-mA charger)
- Two signals are the result of the charger detection state machine:
  - USB100\_P: Valid 100-mA charger (VBUS supplier) is detected.
  - USB500\_P: Valid 500-mA charger (USB charger) is detected.

# **USB Battery Charger FSM**

The FSM uses the control signals CHGDCTRL[6:0] described below to control and observe battery charger detection.

When the SW\_CONTROL bit is set to 1, the current context of the FSM and the state of charger detection is latched in POWER\_CONTROL register bits HWDETECT, DP\_VSRC\_EN, VDAT\_DET, and DET\_COMP, after which FSM control signals CHGDCTRL[6:0] are ignored, and charger detection hardware and the CHGR\_DET pin are controlled by the software.

The CHGD\_IDP\_SRC\_EN bit is not latched when the SW\_CONTROL bit is set (for example, if the FSM is performing data-contact detection at the time the SW\_CONTROL is set to 1, the CHGD\_IDP\_SRC\_EN bit is unchanged — its default value is 0).

CONTROL SIGNAL	CONTROL SIGNAL	DESCRIPTION	TYPE
Bit(6)	USB500_P	500-mA USB charging can be enabled	Input
Bit(5)	USB100_P	100-mA USB charging can be enabled	Input
Bit(4)	CHGD_DET_EN	Enable charger detection (used to enable CHGD IBIAS block)	Output
Bit(3)	CHGD_IDP_SRC_EN	Enable IDP_SRC and RDM_DWN	Output
Bit(2)	CHGD_VDP_SRC_EN	Enable VDP_SRC buffer, IDM_SINK, and VDAT_REF_DM comp	Output
Bit(1)	CHGD_SERX_EN	Enable SERX comparators on DP and DM	Output
Bit(0)	Reserved	Reserved	Output

# FSM Control Signals

#### Table 14. USB Charger Detect FSM I/O Control Signals

Table 14 shows control signals used to control the charger detection analog block from the FSM. The bit number in the left-handed column indicates control bit position used in the charger detection state-machine. Both SERX comparator outputs (CHGD\_SERX\_DP, CHGD\_SERX\_DM) are available for register read in the VENDOR\_SPECIFIC3 register.

Example:			
State:			DCD_INIT
Control:	CHGDCTRL[6:0]	=	011_1010
Bit(6):	USB500_P	=	0
Bit(5):	USB100_P	=	1
Bit(4):	CHGD_DET_EN	=	1
Bit(3):	CHGD_IDP_SRC_EN	=	1

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Bit(2):	
Bit(1):	
Bit(0): Reserved = 0	

=	0
=	1

The Monitoring Analog-to-Digital Convertor (MADC) enables the host processors to monitor analog signals using Analog-to-Digital Conversion (ADC). After the conversion is complete, the host processor reads the results of the conversion through the inter-integrated circuit (I<sup>2</sup>C) interface.

The MADC has the following features:

- 10-bit ADC
- External input (ADCIN0)
- Internal inputs (VBUS, backup battery, and battery voltage)
- · MADC resource shared among multiple users, including system host processors and the internal USB
- Four ways of starting analog-to-digital (ADC) conversion
- Quarter-bit accuracy if the averaging function is used for modem-initiated real-time (RT) conversion requests
- Management of potential concurrent conversion requests and priority between different resource users
- Interrupt signal to the primary interrupt handler (PIH) module at the end-of-sequence of conversions
- Averaging feature to sample the input channel on four consecutive conversion cycles instead of once, and to provide the average value of four conversions

Because the MADC is shared by users, there are four ways to start the ADC conversion. Three of these requests can be triggered by external host processors, and one request is issued by USB:

- Hardware or RT conversion request: This request is initiated by the external host processor to request RT signal conversion. This conversion request is most useful when tied to a modem processor request for battery voltage level, in synchronization with a signal frame boundary. The host processor can request conversion on all ADC input channels using this conversion request.
- SW1 software conversion request: This request can be initiated by the first external host processor to request non-RT conversions. This request is also called an asynchronous or GP conversion (GPC) request.
- SW2 software conversion request: This request can be initiated by the second external host processor to request non-RT conversions. This request is also called an asynchronous or GPC request.
- USB conversion request: This is a GPC request triggered by the USB through TPS65921 internal signals. This conversion request is for the ADCIN12 channel.

It is possible to delay the conversion by programming the acquisition time (ACQUISITION register).

# **JTAG INTERFACES**

The TPS65921 JTAG TAP controller handles standard IEEE JTAG interfaces. This section describes the timing requirements for the tools used to test the TPS65921 power management.

The JTAG/TAP module provides a JTAG interface according to IEEE Std1149.1a. This interface uses the four I/O pins TMS, TCK, TDI, and TDO. The TMS, TCK, and TDI inputs contain a pullup device, which makes their state high when they are not driven. The output TDO is a 3-state output, which is high impedance except when data are shifted between TDI and TDO.

- TCK is the test clock signal.
- TMS is the test mode select signal.
- TDI is the scan path input.
- TDO is the scan path output.

TMS and TDO are multiplexed at the top level with the CPIO0 and CPIO1 pins. The dedicated external TEST pin switches from functional mode (GPIO0/GPIO1) to JTAG mode (TMS/TDO). The JTAG operations are controlled by a state-machine that follows the IEEE Std1149.1a state diagram. This state-machine is reset by the TPS65921 internal power-on reset. A test mode is selected by writing a 6-bit word (instruction) into the instruction register and then accessing the related data register.

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# Keyboard

The keyboard is connected to the chip using:

- KBR (7:0) input pins for row lines
- KBC (7:0) output pins for column lines

Figure 27 shows the keyboard connection.

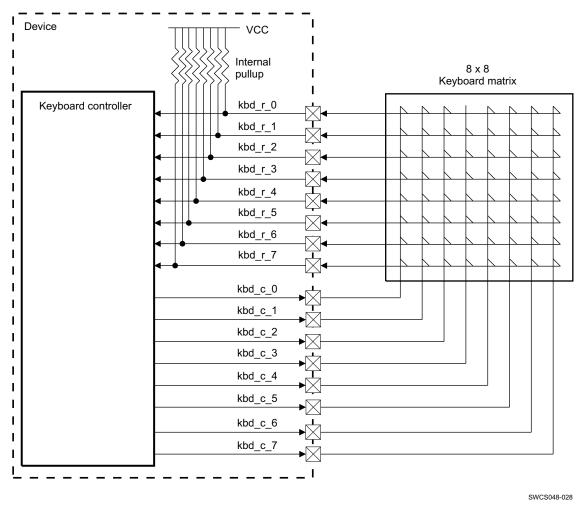


Figure 27. Keyboard Connection

When a key button of the keyboard matrix is pressed, the corresponding row and column lines are shorted together. To allow key press detection, all input pins (KBR) are pulled up to VCC and all output pins (KBC) driven to a low level.

Any action on a button generates an interrupt to the sequencer.

The decoding sequence is written to allow detection of simultaneous press actions on several key buttons.

The keyboard interface can be used with a smaller keyboard area than  $8 \times 8$ . To use a  $6 \times 6$  keyboard, KBR(6) and KBR(7) must be tied high to prevent any scanning process distribution.

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# **PACKAGING INFORMATION**

### Package Information vs. Registers Mapping

FACTDATA0 and FACTDATA1 registers are customer-dedicated registers, which are used to store package information and all other informations needed by the client. These registers are set by EEPROM bits.

#### Table 15. TPS65921 Nomenclature Description

FIELDS	MEANING
P	Marking used to note prototype (X), preproduction (P), or qualified/production device (Blank) <sup>(1)</sup>
A	Mask set version descriptor (initial silicon = BLANK, first silicon revision = A, second silicon revision = $B,$ ) <sup>(2)</sup>
YM	Year month
LLLLS	Lot code
\$	Fab planning code

(1) Blank in the symbol or part number are collapsed so there are no gaps between characters.

(2) Initial silicon version is ES1.0; first revision can be named ES2.0, ES1.1, or ES1.01 depending on the level of change. NOTE: Device name maximum is 10 characters.

# **Thermal Characteristics**

#### Table 16. TPS65921 Thermal Resistance Characteristics

Package	θ <sub>JA</sub> (°C/W)	θ <sub>JB</sub> (°C/W)	θ <sub>JC(top)</sub> (°C/W)	Board Type
TPS65921ZQZ	46	17	20 <sup>(1)</sup>	2S2P <sup>(2)</sup>

(1) Not applicable. Because the POP package has a memory package on top, no heat sink can be used.

(2) The board types are defined by JEDEC (reference JEDEC standard JESD51-9, Test Board for Area Array Surface Mount Package Thermal Measurements).

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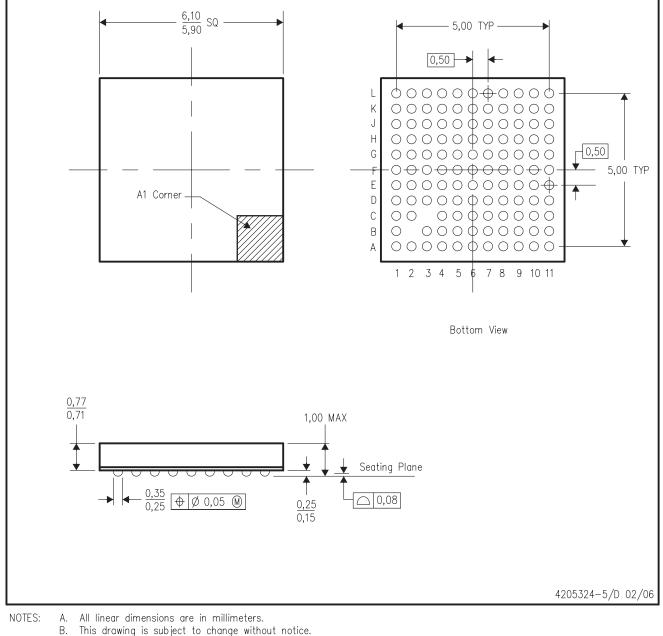
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# Mechanical Data (TPS65921ZQZ)

Figure 28 shows the TPS65921ZQZ mechanical package (6 x 6 mm<sup>2</sup> body, 0.5-mm pitch).

ZQZ (S-PBGA-N120)

# PLASTIC BALL GRID ARRAY



- B. This drawing is subject to change w C. Falls within JEDEC MO-225
  - D. This package is lead-free.

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# Figure 28. TPS65921ZQZ Mechanical Package

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## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
TPS65921BZQZ	PREVIEW	BGA MICROSTAR JUNIOR	ZQZ	120	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	Samples Not Available
TPS65921BZQZR	PREVIEW	BGA MICROSTAR JUNIOR	ZQZ	120	2000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	Samples Not Available

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

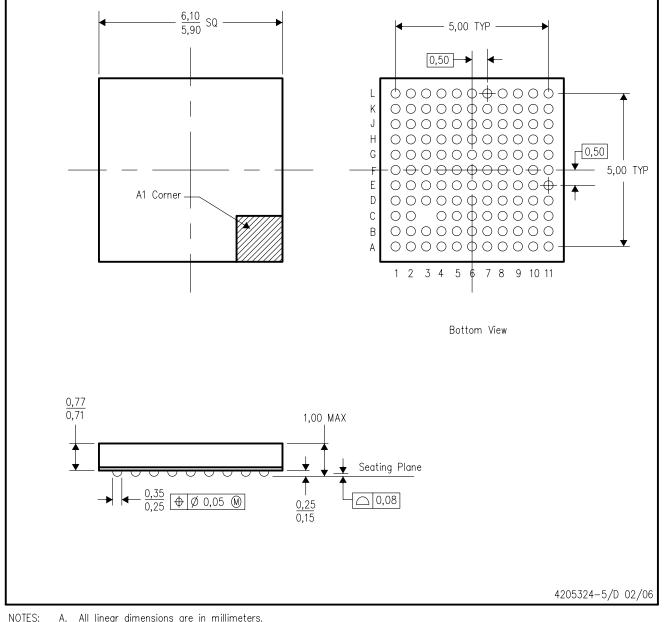
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ZQZ (S-PBGA-N120)

PLASTIC BALL GRID ARRAY



- Α. All linear dimensions are in millimeters.
  - Β. This drawing is subject to change without notice.
  - Falls within JEDEC MO-225 C.
  - D. This package is lead-free.



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